

UM11658

FRDMGD3160DSBHB half-bridge evaluation board

Rev. 1 — 23 September 2021

User manual

Document information

Information	Content
Keywords	GD3160, FRDMGD3160DSBHB, VE-Trac™ Dual DSB IGBT, FRDM-KL25Z, GD3160 Translator Board, half-bridge, FlexGUI
Abstract	The FRDMGD3160DSBHB is a half-bridge evaluation kit populated with two GD3160 single channel gate drive devices.



Revision history

Table 1. Revision history

Revision	Date	Description
UM11658 V.1	20210923	Initial release
Modifications	NA	

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This evaluation kit is intended for use of ENGINEERING DEVELOPMENT OR EVALUATION PURPOSES ONLY. It is provided as a sample IC pre-soldered to a printed circuit board to make it easier to access inputs, outputs, and supply terminals. This evaluation board may be used with any development system or other source of I/O signals by simply connecting it to the host MCU or computer board via off-the-shelf cables. This evaluation board is not a Reference Design and is not intended to represent a final design recommendation for any particular application. Final device in an application will be heavily dependent on proper printed circuit board layout and heat sinking design as well as attention to supply filtering, transient suppression, and I/O signal quality.

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1 Getting Started

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The tool summary page for FRDMGD3160DSBHB is at <http://www.nxp.com/FRDMGD3160DSBHB>. The tool summary page provides an overview of the device, product features, a description of the kit contents, a list of (and links to) supported devices, a list of (and links to) any related products.

The page contains the following four tabs (Note: you can also scroll down the page to view each of the below items):

- **Overview:** summarization of the product and its components
- **Specifications:** basic technical and functional product specifications
- **Buy:** information on how to purchase the product, either directly from NXP or through a distributor
- **Design Resources:** links for downloading documents, schematics, Bill of Materials, Gerber files, and related software

1. Go to <http://www.nxp.com/FRDMGD3160DSBHB>.
2. To download the design resources included with the product, select the **Design Resources** tab and do the following:
 - Download the FRDMGD3160DSBHB schematics, Gerber files, and BOM (if applicable.)
 - Download the FlexGUI for GD31xx Advanced Gate Driver Evaluation Software.
 - Note that, in the **Documents** section, the "Get Started with the FRDMGD3160DSBHB" links back to the **Get Started** section of the tool summary page. The "UM11658, FRDMGD3160DSBHB half-bridge evaluation board - User Manual" links to the document you are currently reading.
3. For a quick review of product contents and features, hardware configuration instructions, and software installation procedures, click on the Overview tab; then click on the **GET STARTED** button in the upper right side of the window.
The **Jump To** section in the panel on the left links to summary information on the product, hardware configuration and software installation instructions, and provides access to related product information and resources.

1.1 Kit contents/packing list

The FRDMGD3160DSBHB kit contents include:

- Assembled and tested FRDMGD3160DSBHB board in an anti-static bag
- 3.3 V to 5.0 V translator board (KITGD3160TREVb) connected to a FRDM-KL25Z board
- USB cable, type A male/type mini B male, 3 ft
- Quick start guide

1.2 Required equipment

To use this kit, you need:

- Compatible VE-Trac™ Dual DSB IGBT module
- DC link capacitor compatible with the VE-Trac™ Dual DSB IGBT module
- 1.27 mm jumpers for configuration (included with kit)
- 30 μ H to 50 μ H, high current air core inductor for double pulse testing
- HV power supply with protection shield and hearing protection
- 25 V, 1.0 A DC power supply
- 500 MHz 2.5 GS/s 4-channel oscilloscope
- Rogowski coil, PEM Model CWT Mini HF60R, or CTW MiniHF30 (smaller diameter)
- Isolated differential high-voltage probes
- Digital voltmeter

1.3 System requirements

The kit requires the following to function properly with the software:

- Windows 7 or higher operating system

2 Getting to Know the Hardware

2.1 Overview

The FRDMGD3160DSBHB is a half-bridge evaluation kit populated with two GD3160 single channel gate drive devices. The kit includes the Freedom KL25Z microcontroller hardware for interfacing with a PC installed with FlexGUI software for communication to the serial peripheral interface (SPI) registers on the GD3160 gate drive devices in either daisy chain or standalone configuration.

The KITGD3160TREV translator board is used to translate 3.3 V signals to 5.0 V signals between the MCU and GD3160 gate drivers. The evaluation kit can be connected to a compatible insulated gate bipolar transistor (IGBT) or SiC module for half-bridge evaluations and applications development.

2.2 Board features

- Capability to connect to VE-Trac™ Dual DSB IGBT module for half-bridge evaluations
- Negative VEE gate low drive level (–7.5 V DC)
- VCCREG regulated high gate drive level (+15 V DC)
- Jumper configurable for disabling dead time fault protection when short-circuit testing
- Easy access power, ground, and signal test points
- Easy to install and use FlexGUI for interfacing via SPI through PC; software includes double pulse and short-circuit testing capability
- DC link bus voltage monitor on low-side driver via AMUXIN and AOUT
- Negative temperature coefficient (NTC) connection and configurable for monitoring module temperature

2.3 Device features

Table 2. Device features

Device	Description	Features
GD3160	The GD3160 is an advanced single channel gate driver for IGBT and SiC MOSFET.	• Compatible with current sense and temp sense IGBTs • DESAT detection capability for detecting V_{CE} desaturation condition • Fast short-circuit protection for IGBTs with current sense feedback • Compliant with automotive safety integrity level (ASIL) C/D ISO 26262 functional safety requirements • SPI interface for safety monitoring, programmability, and flexibility • Integrated galvanic signal isolation • Integrated gate drive power stage capable of 15 A peak source and sink • Interrupt pin for fast response to faults • Compatible with negative gate supply • Compatible with 200 V to 1700 V IGBTs/SiC MOSFET, power range > 125 kW

2.4 Board description

The FRDMGD3160DSBHB is a half-bridge evaluation board populated with two GD3160 single channel IGBT or SiC gate drive devices. The board supports connection to an FRDM-KL25Z microcontroller for SPI communication configuration programming and monitoring. The board includes DESAT circuitry for short-circuit detection and implementation of GD3160 shutdown protection capabilities.

The evaluation board is designed to connect to a VE-Trac™ Dual DSB IGBT module for evaluation of the GD3160 performance and capabilities.

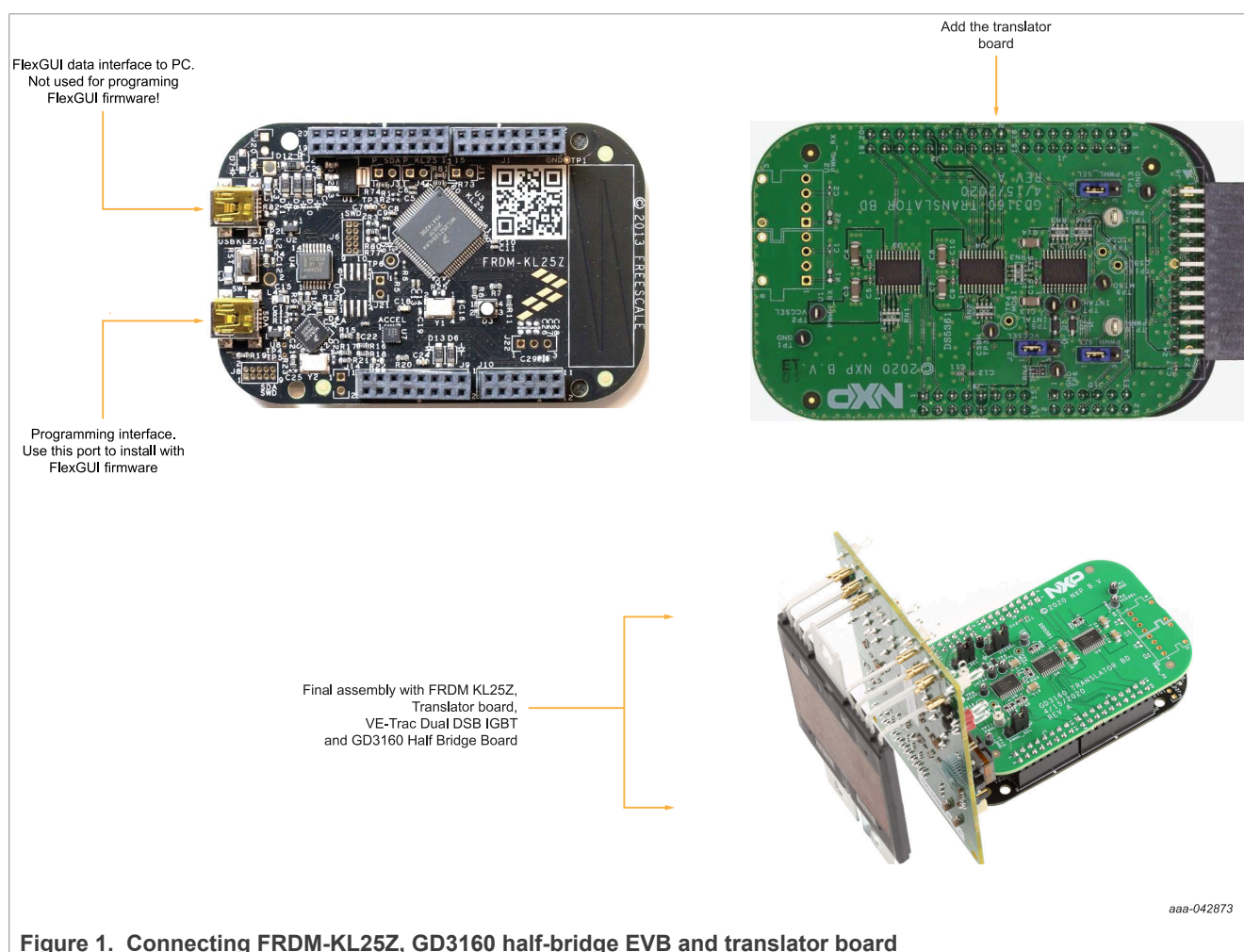


Figure 1. Connecting FRDM-KL25Z, GD3160 half-bridge EVB and translator board

2.4.1 Low-voltage logic and control connector

Low-voltage domain is 12 V VSUP domain that interfaces with the MCU and GD3160 control registers through the 24-pin connector interface.

Low-side driver and high-side driver domains are driver control interfaces to VE-Trac™ Dual DSB IGBT Drive module single phase connections and test points.

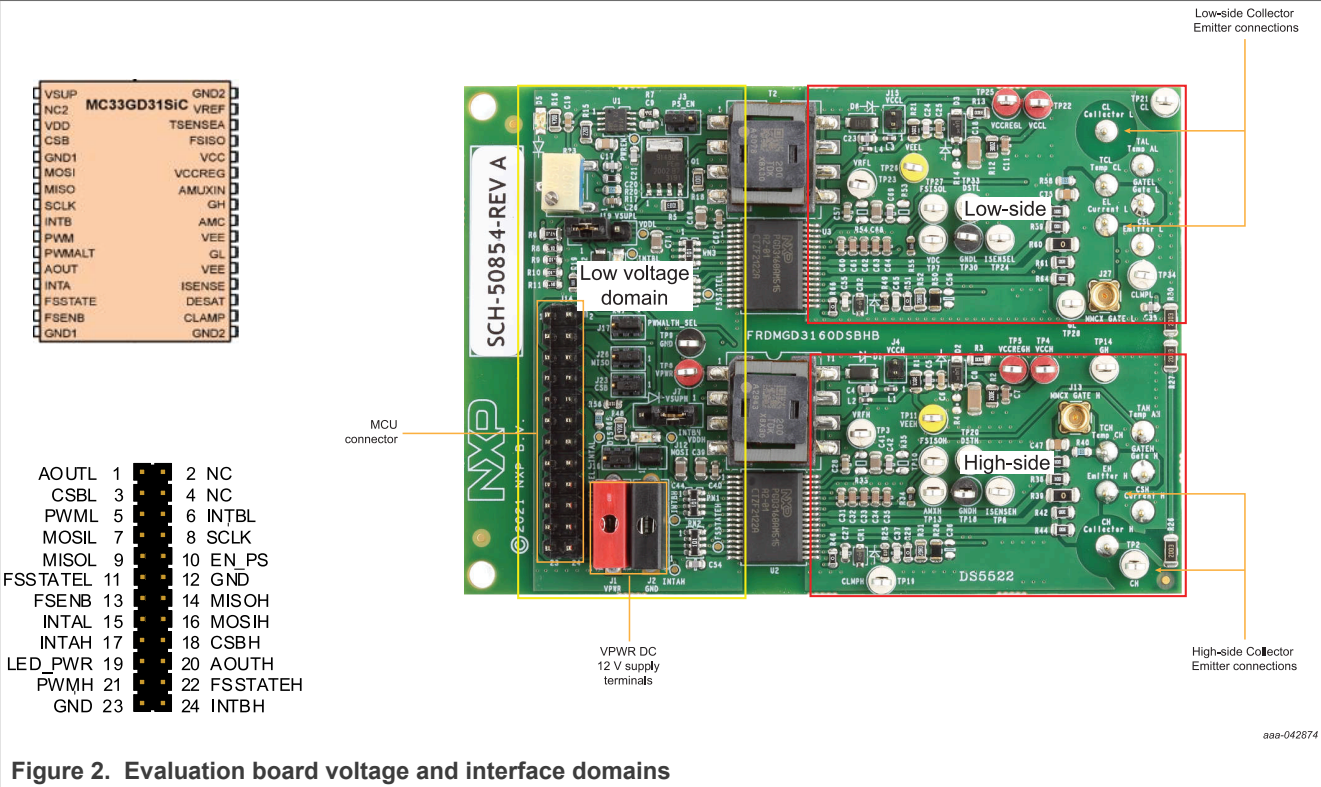


Table 3. Low-voltage domain 24-pin connector definitions

Pin	Name	Function
1	AOUTL	analog output duty cycle encoded signal (low side) for reading temperature via TSENSEA or voltage via AMUXIN
2	n.c.	not connected
3	CSBL	chip select bar (low side)
4	n.c.	not connected
5	PWML	pulse width modulation (PWM) input (low side)
6	INTBL	interrupt bar (low side)
7	MOSIL	master out slave in (low side)
8	SCLK	serial clock input
9	MISOL	master in slave out (low side)
10	EN_PS	MCU control of flyback power supply
11	FSSTATEL	fail-safe state (low side)
12	GND	ground
13	FSENB	fail-safe enable (high side and low side)
14	MISOH	master in slave out (high side)
15	INTAL	fault reporting and real-time V _{CE} and V _{GE} monitoring (low side)
16	MOSIH	master out slave in (high side)
17	INTAH	fault reporting and real-time V _{CE} and V _{GE} monitoring (high side)

Table 3. Low-voltage domain 24-pin connector definitions...continued

18	CSBH	chip select bar (high side)
19	LED_PWR	USB 3.3 V power for INTB LEDs (high side and low side)
20	AOUTH	duty cycle encoded signal (high side)
21	PWMH	PWM input (high side)
22	FSSTATEH	fail-safe state (high side)
23	GND	ground
24	INTBH	interrupt bar (high side)

2.4.2 Test point definitions

All test points are clearly marked on the evaluation board. [Figure 3](#) shows the location of various test points.

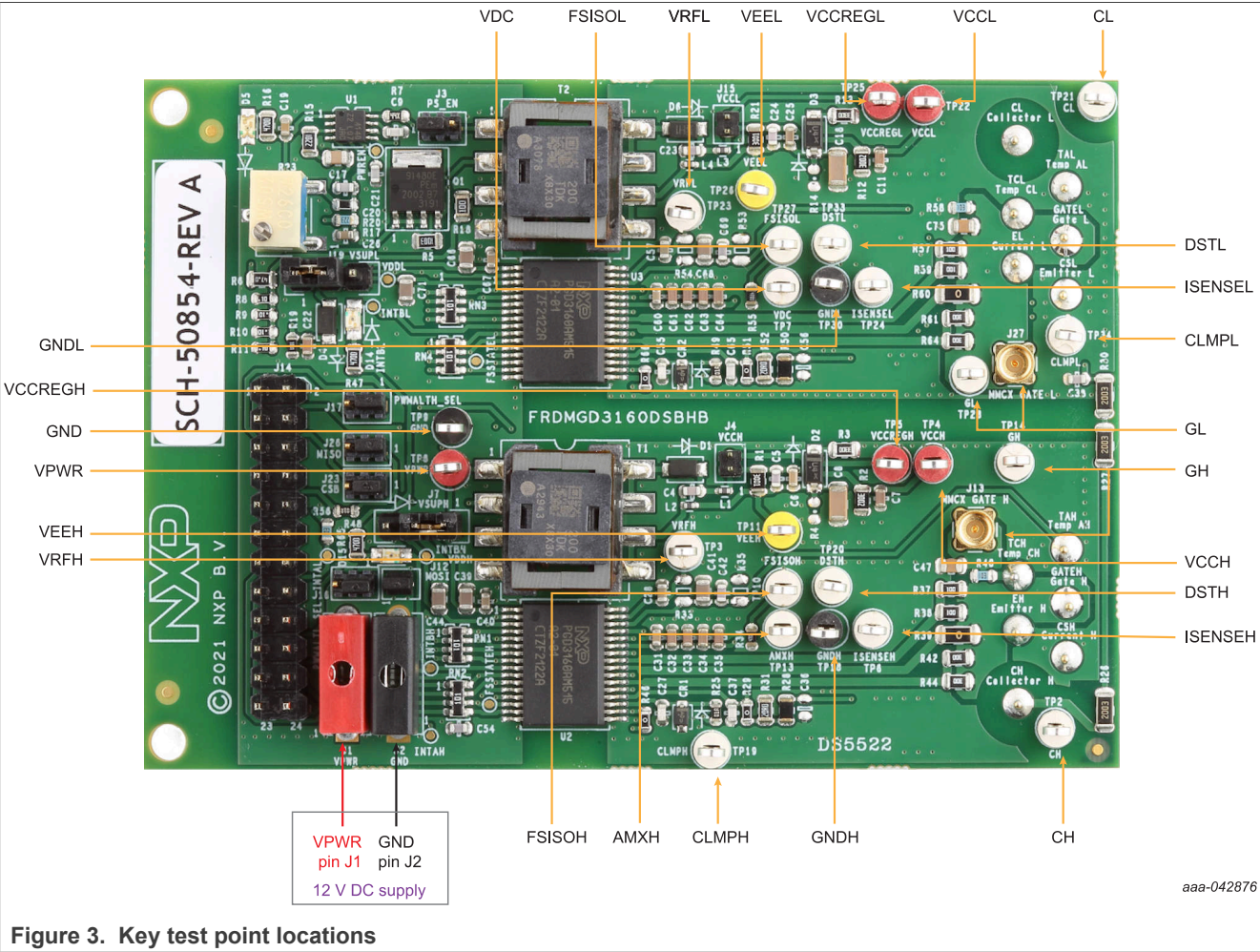


Figure 3. Key test point locations

Table 4. Test point definitions

Test point	Definition
Low-voltage domain	

Table 4. Test point definitions...continued

VPWR	DC voltage source connection point for VSUP power input of GD3160 devices. Typically supplied by vehicle battery +12 V DC.
GND	grounding points for low-voltage domain
INTAH	fault monitor and VCE/VGE monitor high-side test point
INTBL	interrupt bar low-side test point
INTAL	fault monitor and VCE/VGE monitor low-side test point
INTBH	interrupt bar high-side test point
Low-side driver domain	
GNDL	low-side domain ground point
VCCL	positive voltage supply test point for isolated circuitry and low-side driver domain
VRFL	5.0 V reference test point for isolated analog circuitry on low-side driver
GL	module gate test point on low-side driver domain which is the charging pin of gate; including MMCX probe connection
FSISOL	high-voltage domain fail-safe low-side test point
DSTL	V _{CE} desaturation test point connected to low-side driver DESAT pin and circuitry
VCCREGL	VCC regulator low-side test point
VEEL	negative voltage supply test point for low-side driver gate of IGBT or SiC module
CLMPL	active clamping low-side test point
VDC	DC link voltage test point at voltage divider
CL	collector test point/connection terminal on low side
ISENSEL	Current sense feedback test point low-side connected to ISENSE pin.
High-side driver domain	
VCCH	positive voltage supply test point for isolated circuitry and high-side driver domain
GNDH	high-side domain ground point
CH	collector test point/connection high side
VCCREGH	VCC regulator high-side test point
VRFH	5.0 V reference test point for isolated analog circuitry on high-side driver
FSISOH	high-voltage domain fail-safe high-side test point
GH	module gate test point on high-side driver domain which is the charging pin of gate; including MMCX probe connection
CLMPH	active clamping high-side test point
DSTH	V _{CE} desaturation test point connected to high-side driver DESAT pin and circuitry
VEEH	negative voltage supply test point for high-side driver gate of IGBT or SiC module
AMXH	analog MUX input test point for high-side driver
ISENSEH	Current sense feedback test point high-side connected to ISENSE pin.

2.4.3 Power supply and jumper configuration

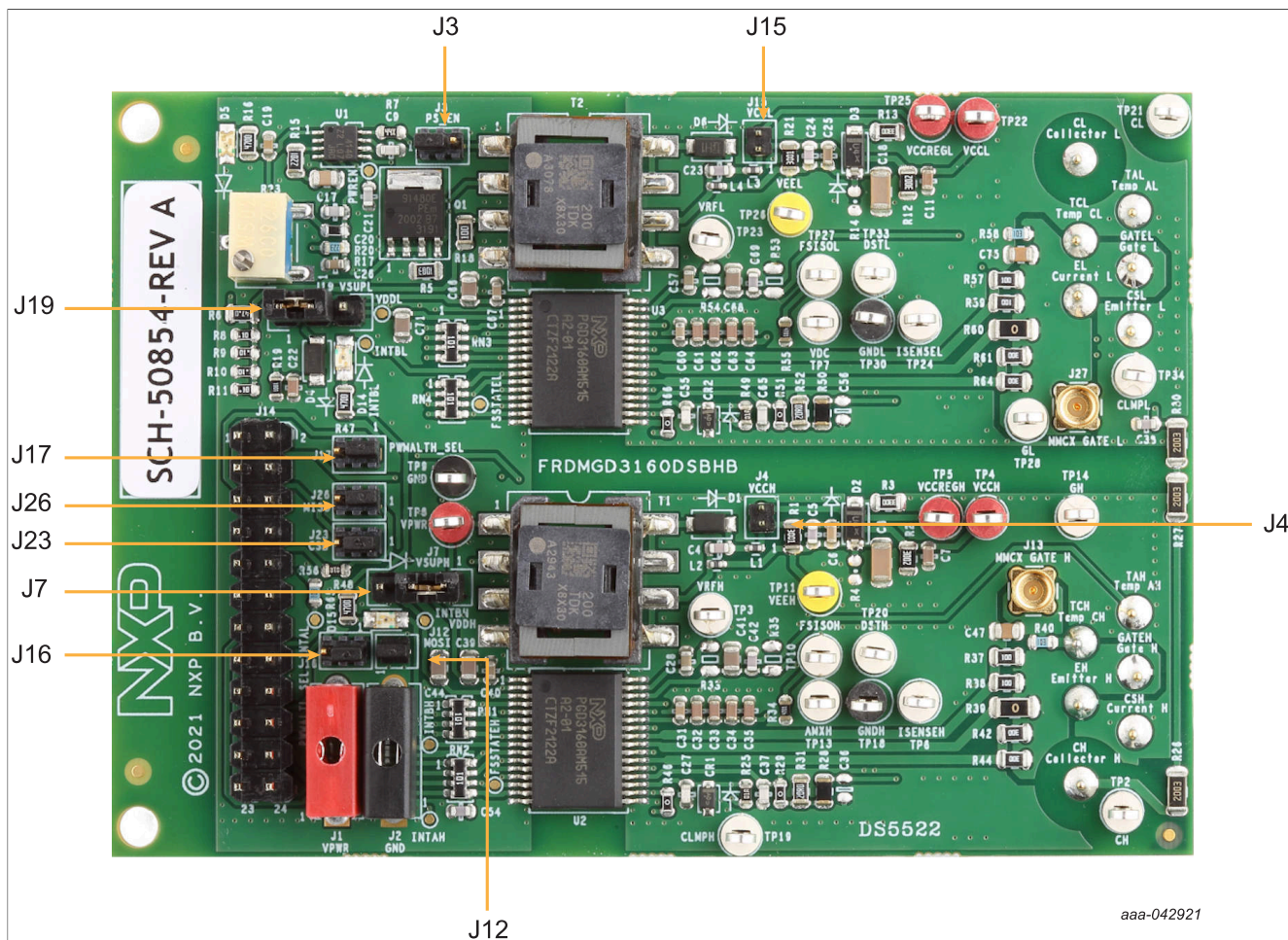


Figure 4. Power supply and jumper configuration

Table 5. Jumper definitions

Jumper	Position	Function
PWMALTH_SEL (J16)	1-2	dead time fault protection enabled (high side)
	2-3	dead time fault protection disabled (use for short-circuit testing)
PWMALTL_SEL (J17)	1-2	dead time fault protection enabled (low side)
	2-3	dead time fault protection disabled (use for short-circuit testing)
VCCH (J4) and VCCL (J15)	open	VCCREG controls gate voltage
	closed	VCC and VCCREG are tied together
VSUPH (J7) and VSUPL (J19)	open	internally regulated supply derived from VSUP
	closed	VSUP = VDD for 5 V or 3.3 V operation depending on the part number
CSB (J23)	1-2	chip select for normal operation
	2-3	chip select for daisy chain operation
MOSI (J12)	closed	normal operation
	open	daisy chain operation

Table 5. Jumper definitions...continued

MISO (J26)	1-2	normal operation
	2-3	daisy chain operation
PS_EN (J3)	1-2	MCU control of flyback supply enable
	2-3	flyback supply enable tied to VSUP

2.4.4 Bottom view

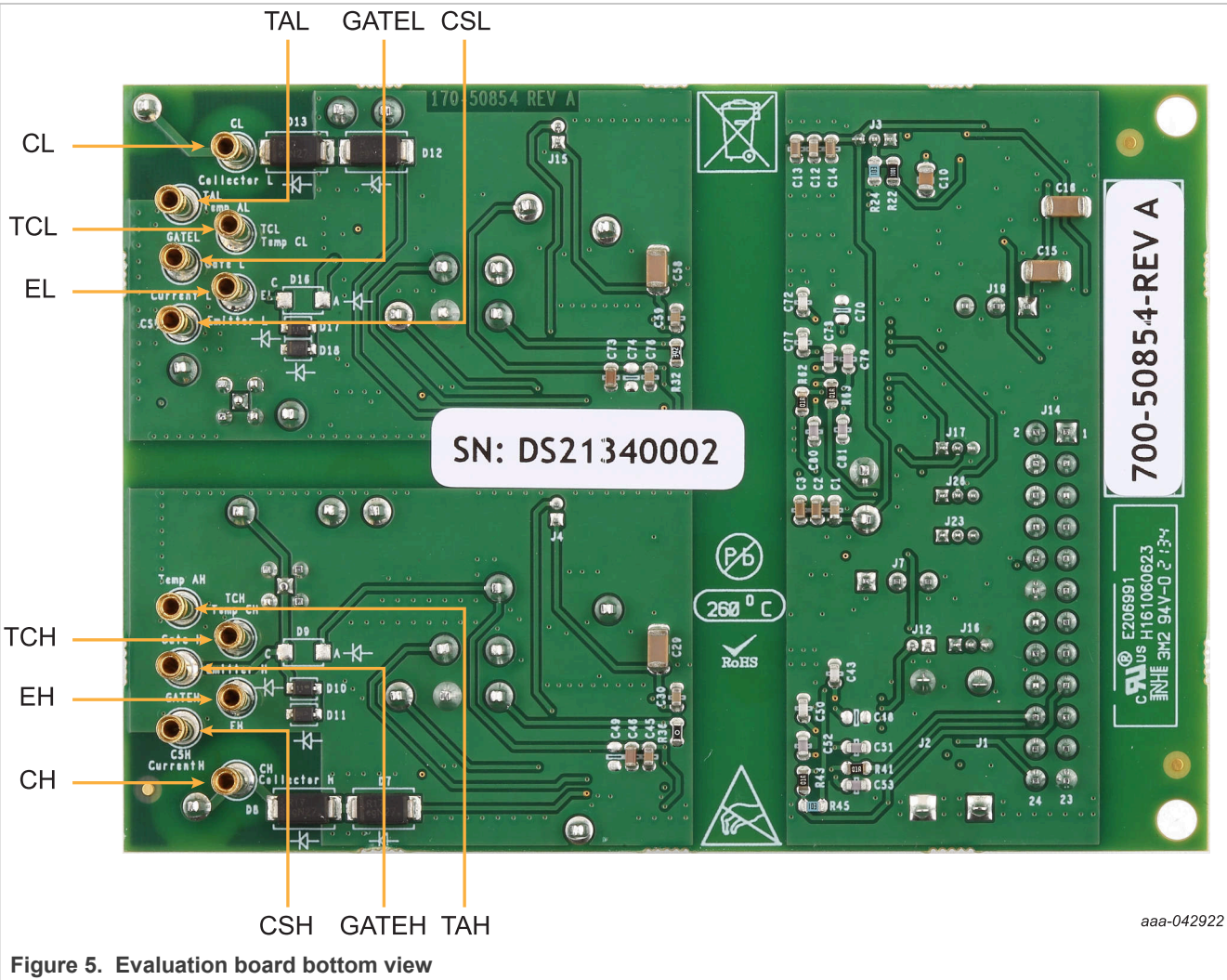


Figure 5. Evaluation board bottom view

Table 6. Bottom of board connectors

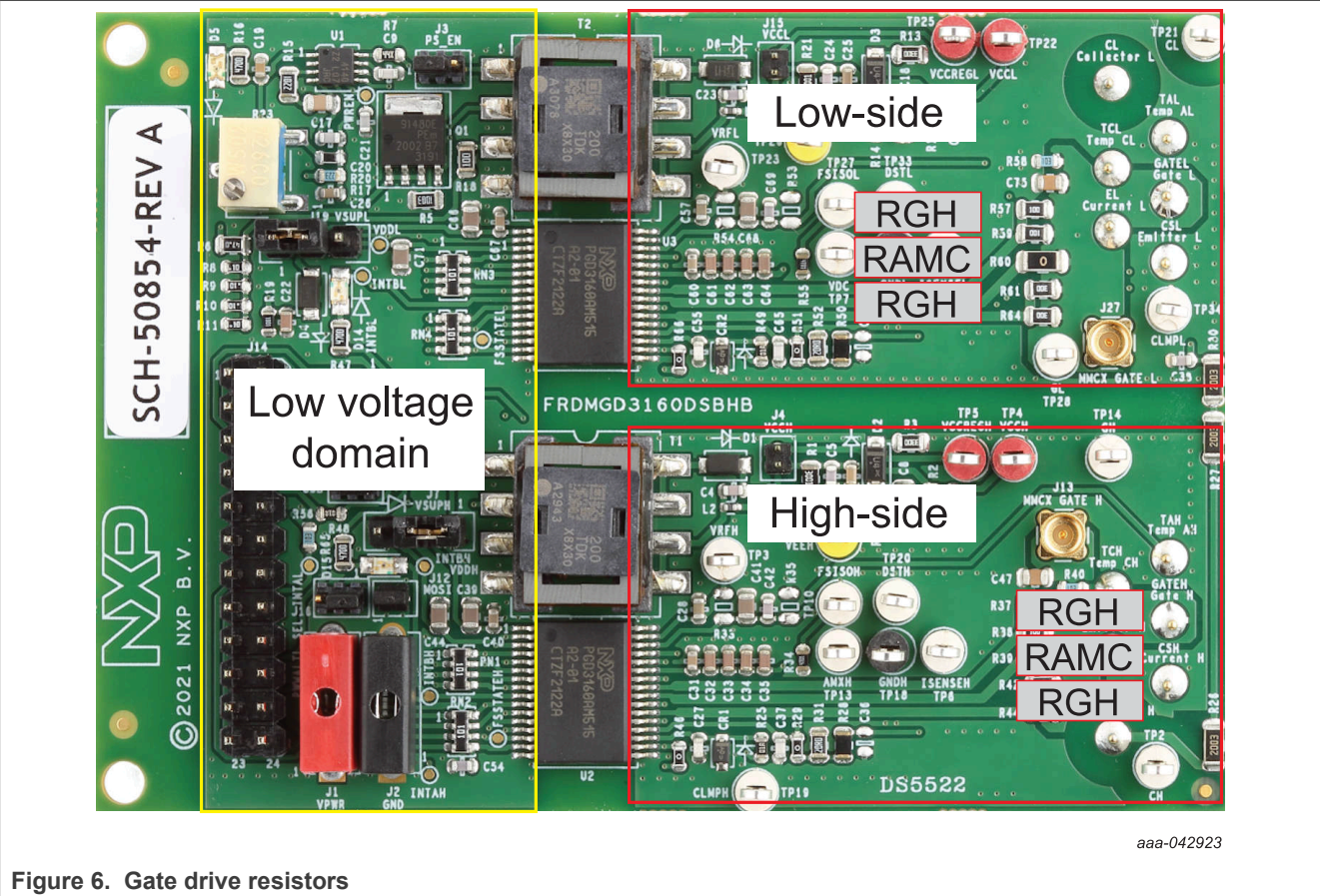
Connection	Description
CH	High Side Collector
CSH	High Side Collector Sense
EH	High Side Emitter Sense
GATEH	High Side Gate
TCH	High Side Temp Sense Cathode

Table 6. Bottom of board connectors...continued

TAH	High Side Temp Sense Anode
CSL	Low Side Collector Sense
EL	Low Side Emitter Sense
GATEL	Low Side Gate
TCL	Low Side Temp Sense Cathode
TAL	Low Side Temp Sense Anode
CL	Low Side Collector

2.4.5 Gate drive resistors

- RGH - gate high resistor in series with the GH pin at the output of the GD3160 gate high driver and VE-Trac™ Dual DSB IGBT module gate that controls the turn-on current for SiC MOSFET gate.
- RGL - gate low resistor in series with the GL pin at the output of the GD3160 gate low driver and VE-Trac™ Dual DSB IGBT module gate that controls the turn-off current for SiC MOSFET gate.
- RAMC - series resistor between VE-Trac™ Dual DSB IGBT module gate and AMC input pin of the GD3160 driver for gate sensing and active Miller clamping.



2.4.6 LED interrupt indicators

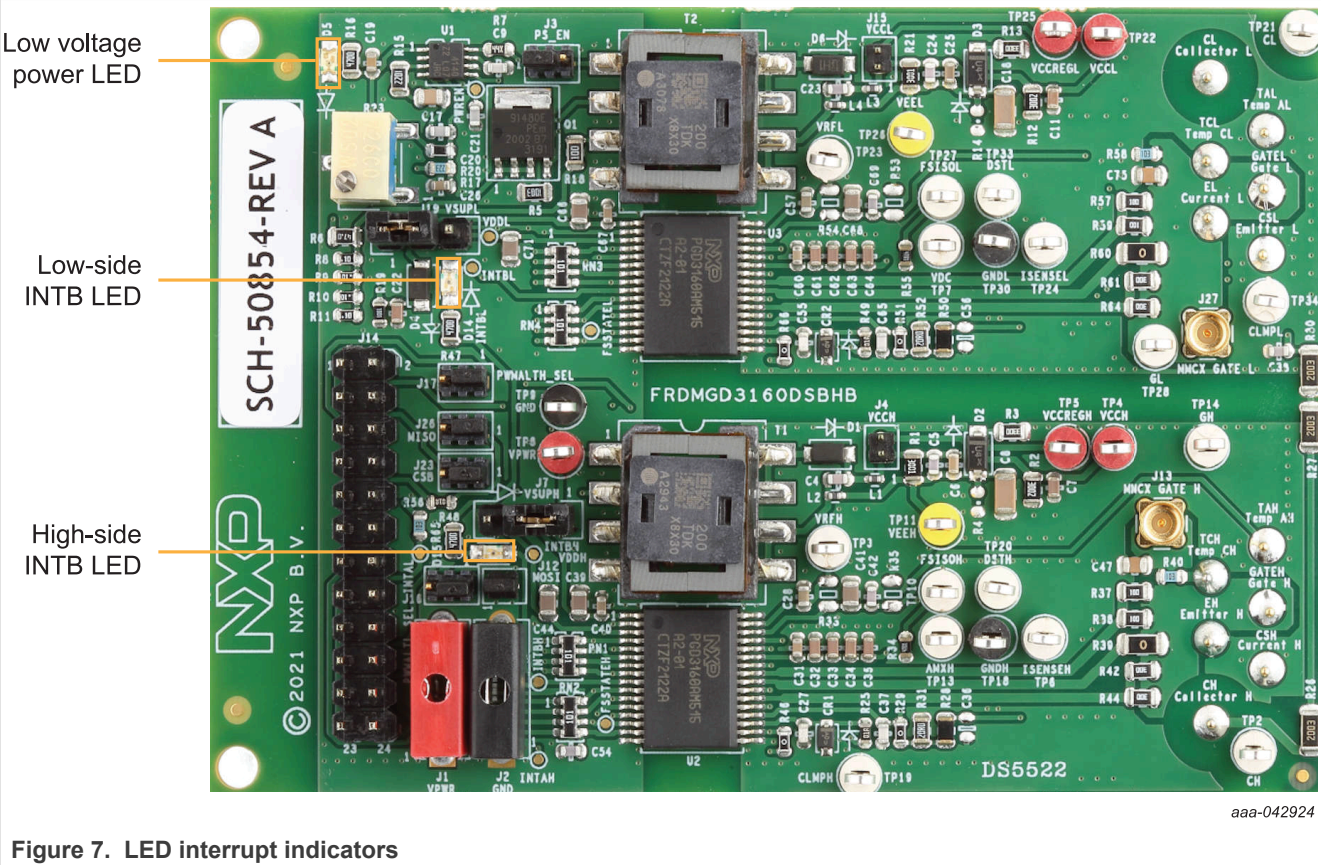


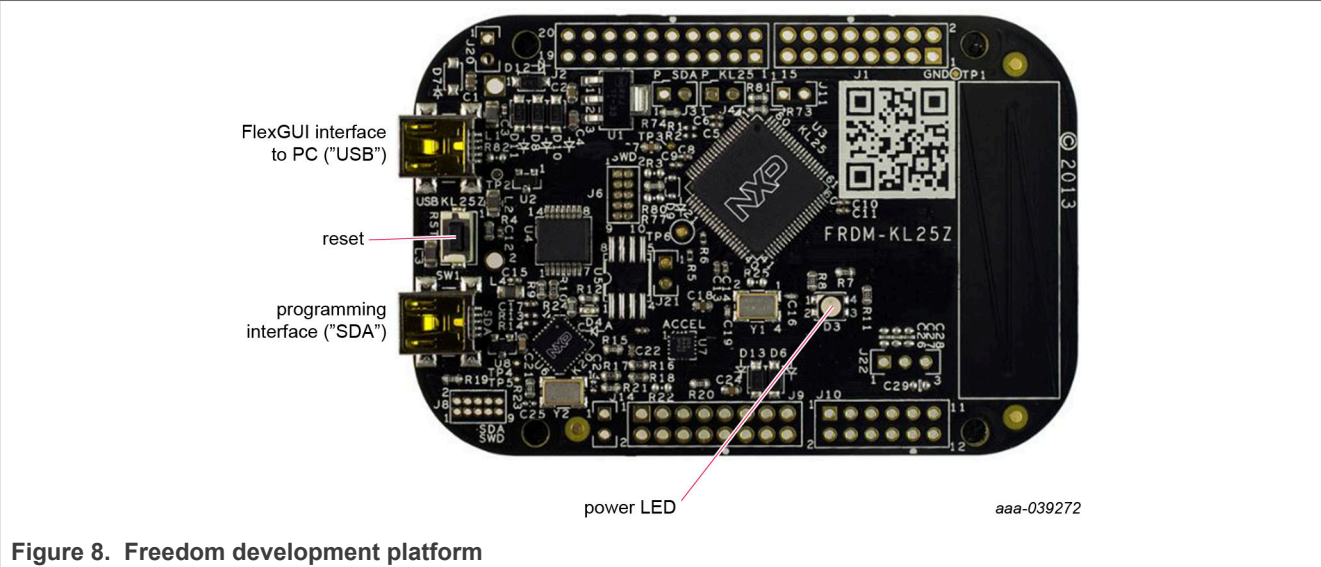
Figure 7. LED interrupt indicators

Table 7. LED interrupt indicators

LED	Description
Low-side INTB	connected to the INTB output pin of low-side driver indicating reported fault status when on (active LOW)
High-side INTB	connected to the INTB interrupt output pin of high-side driver indicating reported fault status when on (active LOW)

2.5 Kinetis KL25Z Freedom board

The Freedom KL25Z is an ultra low-cost development platform for Kinetis L series MCU built on Arm Cortex-M0+ processor.



2.6 3.3 V to 5.0 V translator board

KITGD3160TREVB translator enables level shifting of signals from MCU 3.3 V to 5.0 V SPI communication.

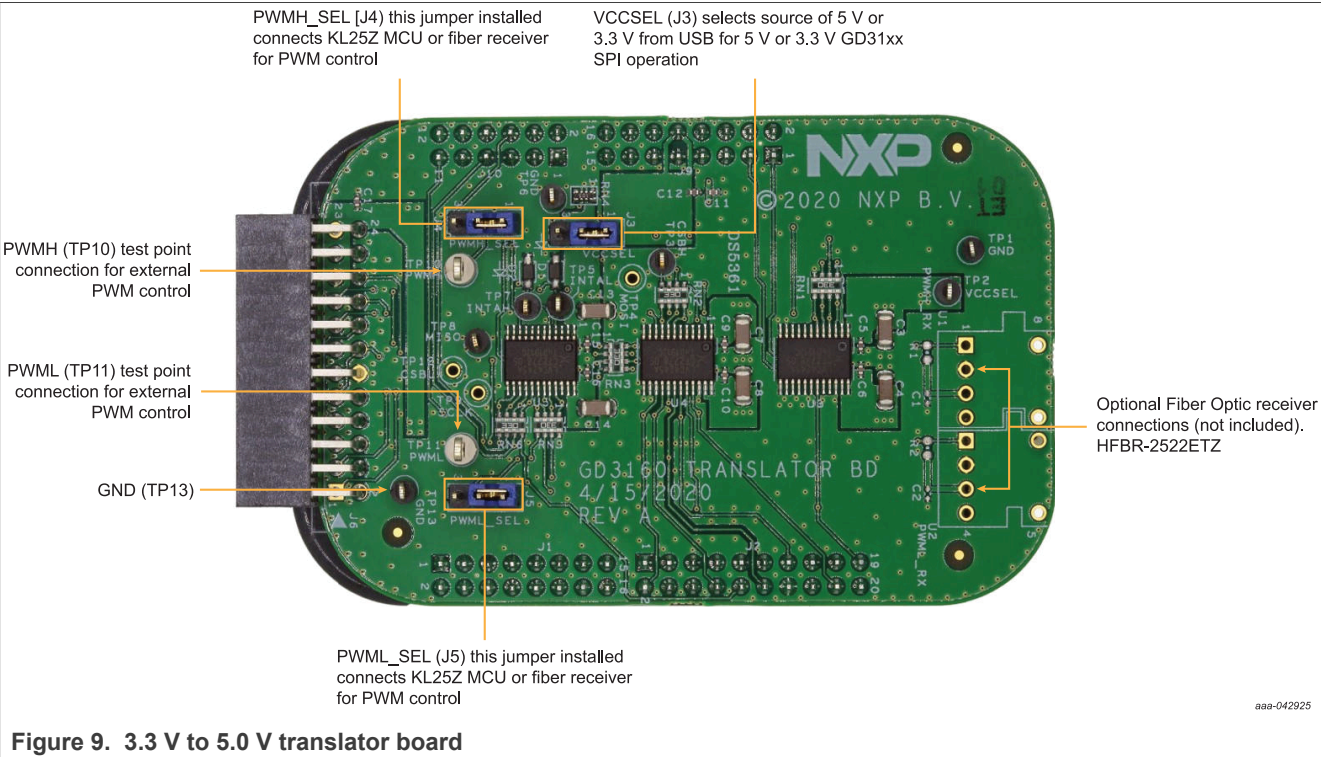


Table 8. Translator board jumper definitions

Jumper	Position	Function
VCCSEL (J3)	1-2	selects 5.0 V for 5.0 V compatible gate drive
	2-3	selects 3.3 V for 3.3 V compatible gate drive

Table 8. Translator board jumper definitions...continued

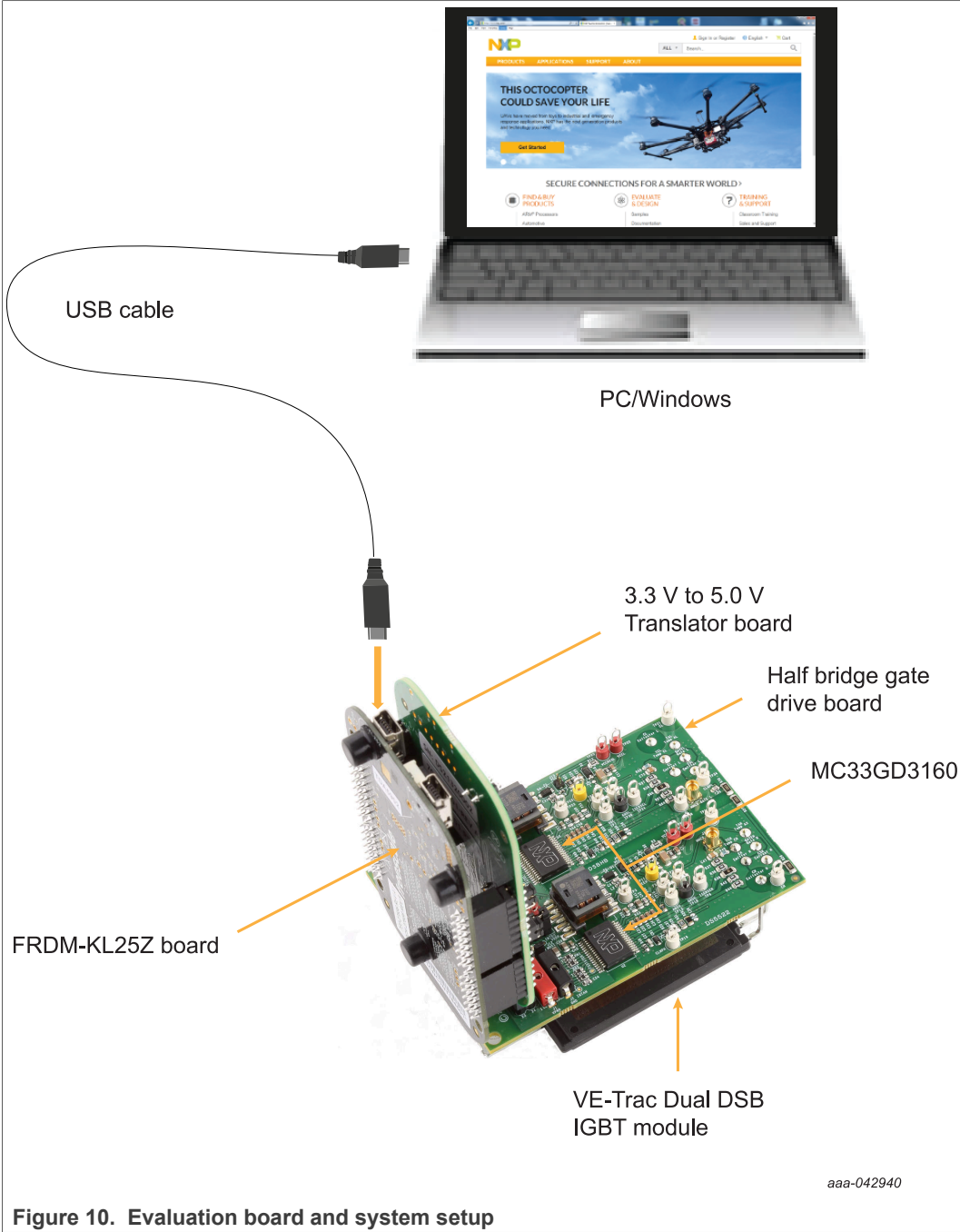
PWMH_SEL (J4)	1-2	selects PWM high-side control from KL25Z MCU
	2-3	selects PWM high-side control from fiber optic receiver inputs
PWML_SEL (J5)	1-2	selects PWM low-side control from KL25Z MCU
	2-3	selects PWM low-side control from fiber optic receiver inputs

3 Configuring the Hardware

FRDMGD3160DSBHB is connected to compatible SiC MOSFET VE-Trac™ Dual DSB IGBT module with a DC link capacitor as shown in [Figure 11](#). Double pulse and short-circuit testing can be conducted utilizing Windows-based PC with FlexGUI software.

Suggested equipment needed for test:

- Rogowski coil high-current probe
 - High-voltage differential voltage probe
 - High sample rate digital oscilloscope with probes
 - DC link capacitor compatible with VE-Trac™ Dual DSB IGBT module
 - VE-Trac™ Dual DSB IGBT module
 - Windows-based PC
 - High-voltage DC power supply for DC link voltage
 - Low-voltage DC power supply for VPWR
- +12 V DC gate drive board low-voltage domain
- Voltmeter for monitoring high-voltage DC link supply
 - Load coil for double pulse testing



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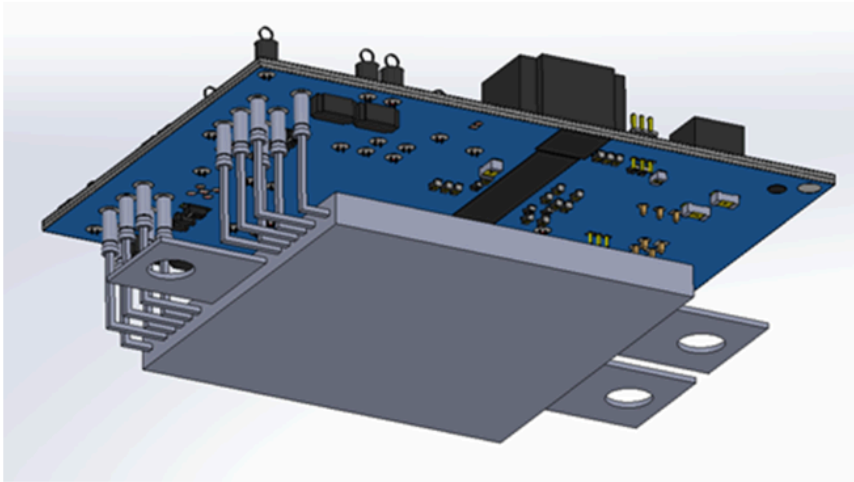


Figure 11. Evaluation board and power module connection

DSB module dimensions

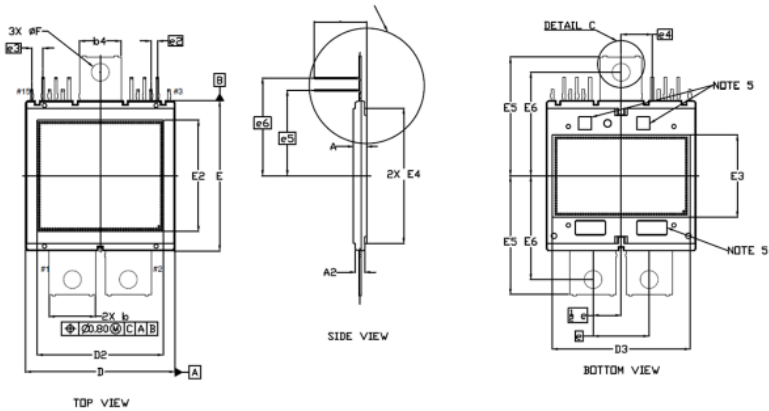


Figure 13.

Figure 12. Power module dimensions

4 Installation and Use of Software Tools

Software for FRDMGD3160DSBHB is distributed with the FlexGUI tool (available at nxp.com). Necessary firmware comes pre-installed on the FRDM-KL25Z with the kit.

Even if the user intends to test with other software or PWM, this software should be installed as a backup or as an aid in debugging.

4.1 Installing the FlexGUI on your computer

The latest version of FlexGUI supports the GD3100 and GD3160. It is designed to run on any Windows 10 or Windows 8 based operating system.

By default, the FlexGUI executable file is installed at **C:\flexgui-app-des-gd31xx.exe**. Installing the device drivers overwrites any previous FlexGUI installation and replaces it with a current version containing the GD31xx drivers. However, configuration files (.spi) from the previous version remain intact.

To install the software, do the following:

1. Go to www.nxp.com/FlexGUI and click on the **Download** tab.
2. When the "Graphics, UI, and Human Machine Interface" page appears, click the **Download** button associated with "FlexGUI for GD31xx Advanced Gate Driver Evaluation Software". When prompted, provide a location where the FlexGUI files are to be downloaded.

FlexGUI: Software Tool for Evaluation of Reference Design Kits

OVERVIEW DOCUMENTATION **DOWNLOADS** DEVELOPMENT TOOLS

Filter By: Show All

Filter by keyword

Embedded Application Software (0)

Graphics, UI, and Human Machine Interface (6)

Graphics, UI, and Human Machine Interface (6)

FlexGUI for GD31xx Advanced Gate Driver Evaluation Software **UPDATED**

This is a graphical user interface (GUI) application based on the FlexGUI framework. It enables user to evaluate functionality of the GD31xx advanced single-channel gate driver family.

ZIP Rev 0.7.0.9 2021-06-25 18:16:00 61.5 MB flexgui-app-des-gd31xx

DOWNLOAD

FlexGUI for UJA1164A and UJA1168A SBCs

This is the graphical user interface (GUI) based on FlexGUI framework. This application enables user to evaluate functionality of UJA1164A and UJA1168A Mini high-speed CAN SBCs.

ZIP Rev 1.0 2021-05-05 18:19:00 43.5 MB FLEXGUI-APP-UVN-UJA116X

DOWNLOAD

FlexGUI for PF8100/8200/8101/8201/8121 Family

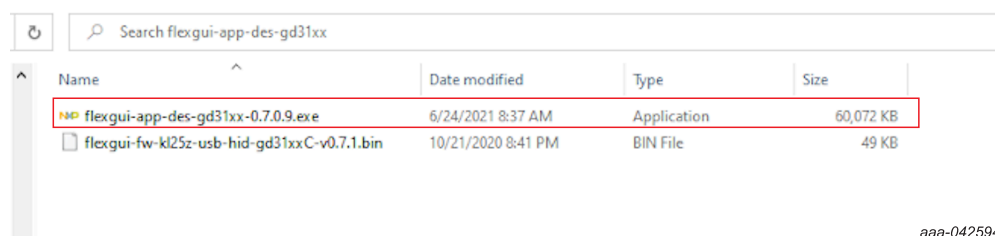
This is the graphical user interface (GUI) based on FlexGUI framework. This application enables user to evaluate functionality of PF8100 device family.

ZIP Rev 1.0.1 2020-10-07 10:56:00 9.4 MB FlexGUI-PF8X

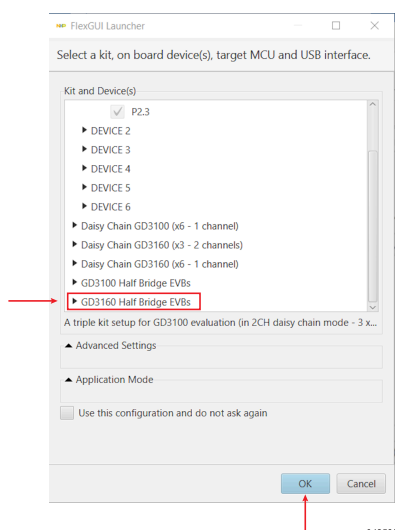
More

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- Unzip the downloaded file. Then click on **C:\flexgui-app-des-gd31xx.exes** to open the installation wizard.



- Follow the installation wizard prompts on the "License Agreement" and the "Select Destination Location" windows.
- At the end of the installation process the FlexGUI automatically opens to the "Kit and Device(s)" selection window. Select **GD3160 Half Bridge EVBs**, then click **OK**. Do not change any other parameters on this page.



4.2 Configuring the FRDM-KL25Z microcode

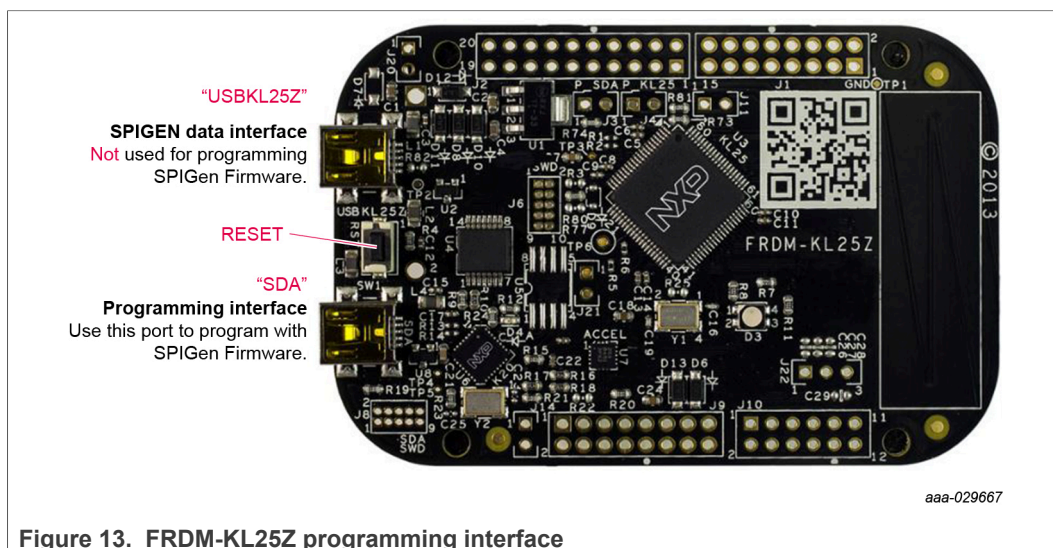


Figure 13. FRDM-KL25Z programming interface

By default, the FRDM-KL25Z delivered with this kit is preprogrammed with the current and most up-to-date firmware available for the kit.

A way to check quickly that the microcode is programmed and the board is functioning properly, is to plug the KL25Z into the computer, open FlexGUI, and verify that the software version at the bottom is 6.4 or later (see [Figure 14](#)).

If a loss of functionality following a board reset, re-programming, or a corrupted data issue, the microcode may be rewritten per the following steps:

1. To clear the memory and place the board in boot loader mode, hold down the reset button while plugging a USB cable into the **OpenSDA** USB port.
2. Verify that the board appears as a BOOTLOADER device and continue with step 3. If the board appears as KL25Z, you may go to step 6.
3. Download the **Firmware Apps** .zip archive from the PEmicro OpenSDA webpage (<http://www.pemicro.com/opensda/>). Validate your email address to access the files.
4. Find the most recent MDS-DEBUG-FRDM-KL25Z_Pemicro_v118.SDA and copy/drag-and-drop into the **BOOTLOADER** device.
5. Reboot the board by unplugging and replugging the connection to the **OpenSDA** port. Verify now that the device appears as a KL25Z device to continue.
6. Locate the most recent KL25Z firmware; which is distributed as part of the FlexGUI package.
 - a. From the FlexGUI install directory, which is located in the **flexgui-app-des-gd31xx\bin** folder and is named in the form "flexgui-fw-KL25Z_usb_hid_gd31xxC_vx.x.x.bin".
 - b. This .bin file is a product/family-specific configuration file for FRDM-KL25Z containing the pin definitions, SPI/PWM generation code, and pin mapping assignments necessary to interface with the translator board as part of FRDMGD3160DSBHB.
7. With the KL25Z still plugged through the **OpenSDA** port, copy/drag-and-drop the .bin file into the KL25Z device memory. Once done, disconnect the USB and plug into the other USB port, labeled **KL25Z**.
 - a. The device may not appear as a distinct device to the computer while connected through the KL25Z USB port, this is normal.

8. The FRDM-KL25Z board is now fully set up to work with FRDMGD3160DSBHB and the FlexGUI.
 - a. There is no software stored or present on either the driver or translator boards, only on the FRDM-KL25Z MCU board.

All uploaded firmware is stored in non-volatile memory until the reset button is hit on the FRDM-KL25Z. There is no need to repeat this process upon every power up, and there is no loss of data associated with a single unplug event.

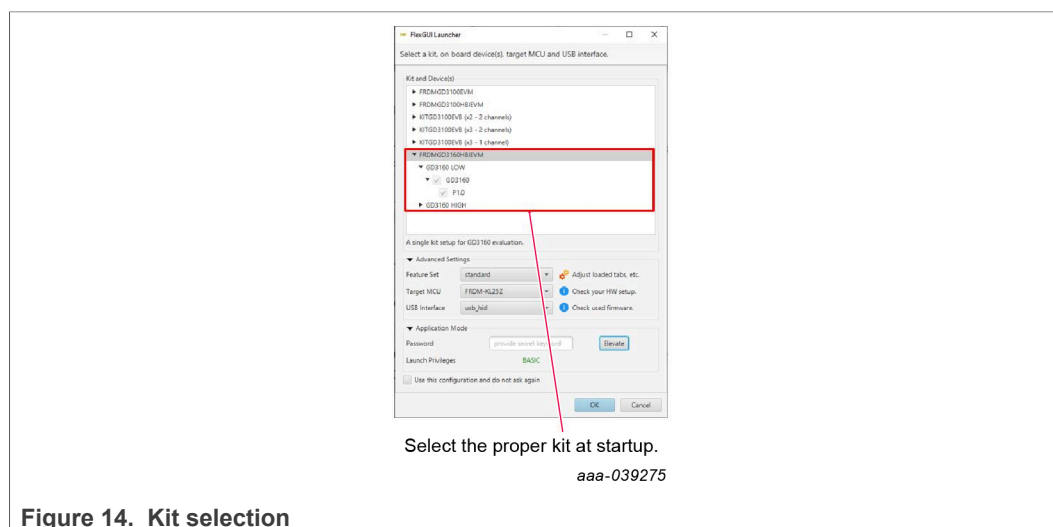
4.3 Using the FlexGUI

The FlexGUI is available from <http://www.nxp.com/FlexGUI> as an evaluation tool demonstrating GD31xx-specific functionality, configuration, and fault reporting. FlexGUI also includes basic capacity for the FRDMGD3160DSBHB to control an IGBT or SiC module, enabling double pulse or short-circuit testing.

SPI messages can be realized graphically or in hexadecimal format. CSB is selectable to address one or both GD31xx on the board via daisy chain. See [Figure 14](#) to [Figure 33](#) for FlexGUI for GD31xx internal register read and write access.

Starting FlexGUI for GD31xx

- FlexGUI install program (flexgui-app-des-gd31xx-0.x.x.exe)
- Download FlexGUI and run the install program on your PC.
- When you start the application, [Figure 14](#) allows you to select the target application board, feature set (standard or daisy chain), target MCU, and USB interface. Leave all settings as shown.



FlexGUI settings

- Access settings by selecting Settings from the File menu

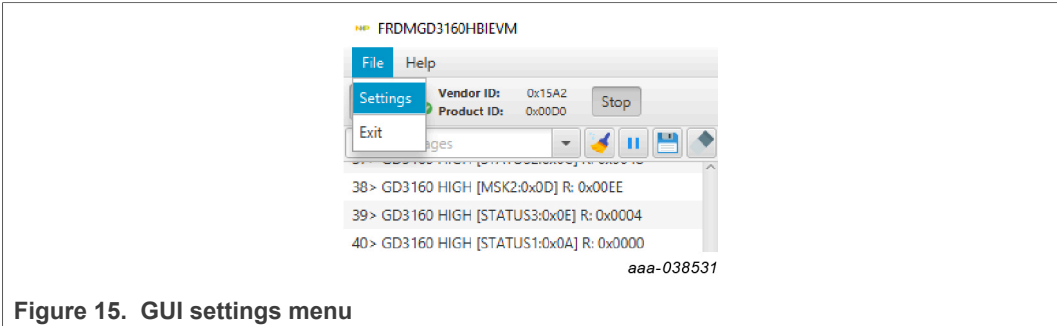


Figure 15. GUI settings menu

- The Loader and Logs settings are shown below:

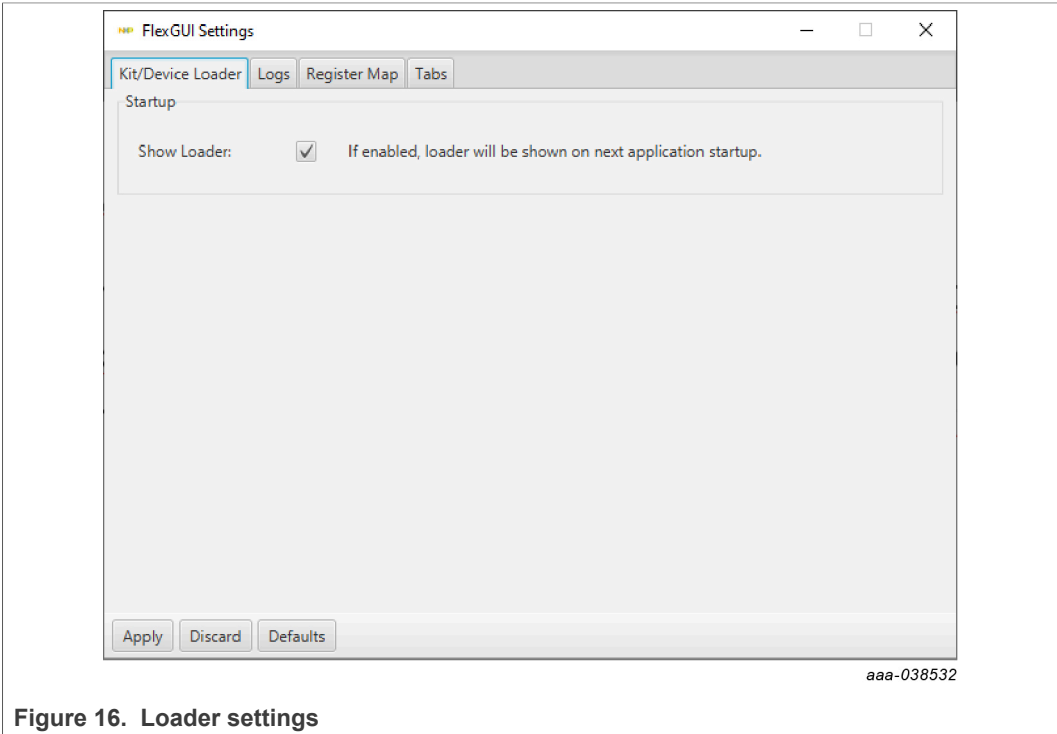


Figure 16. Loader settings

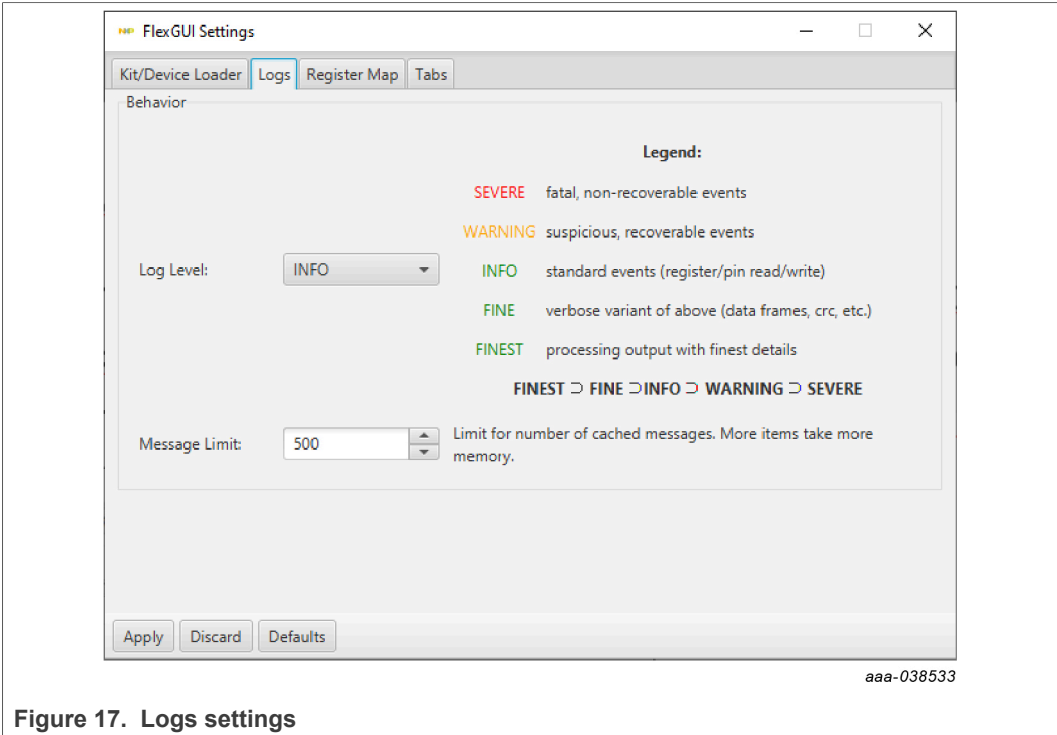


Figure 17. Logs settings

- Access settings by selecting Settings from the File menu.
- The Register Map and Tabs settings are shown below:

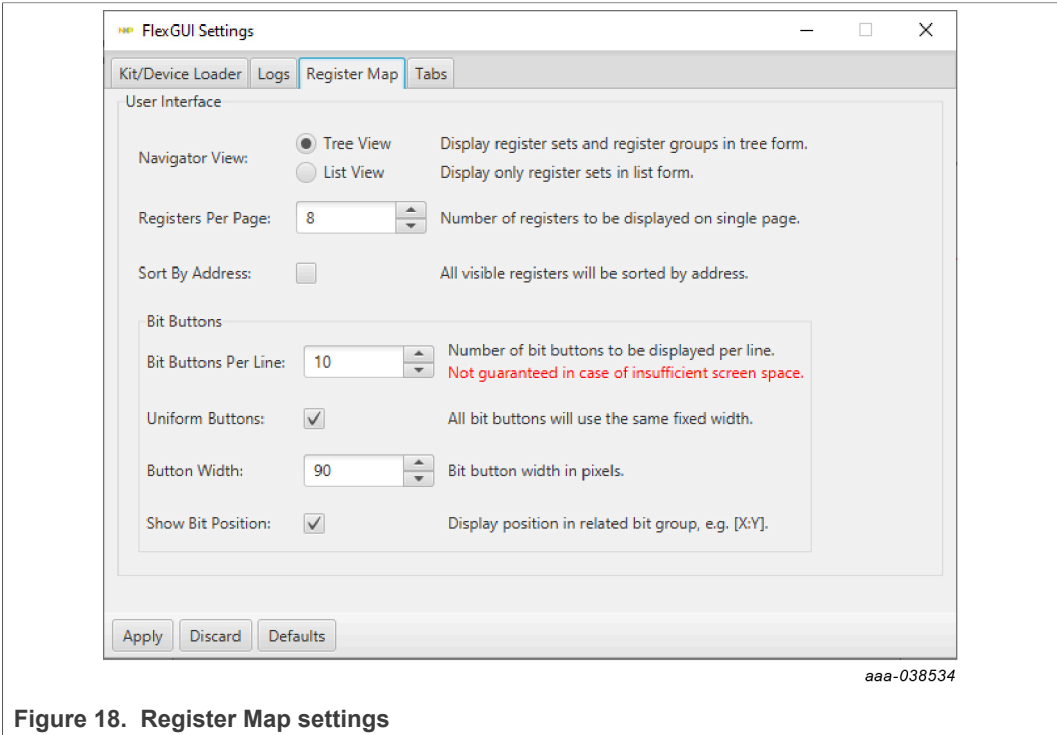


Figure 18. Register Map settings

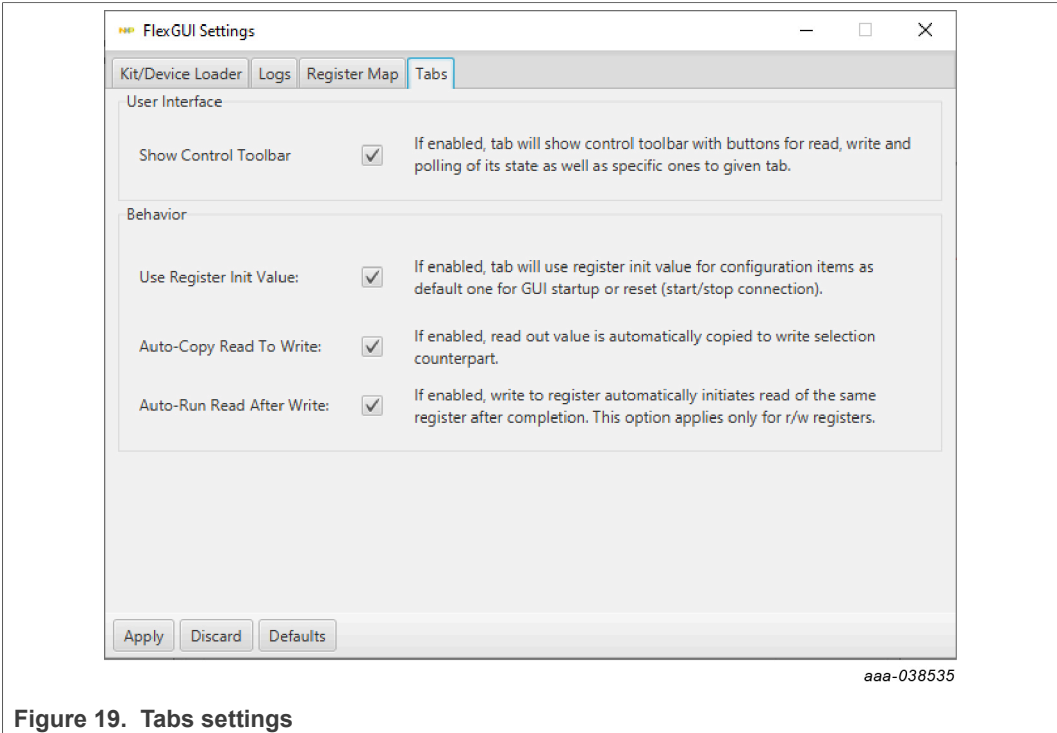
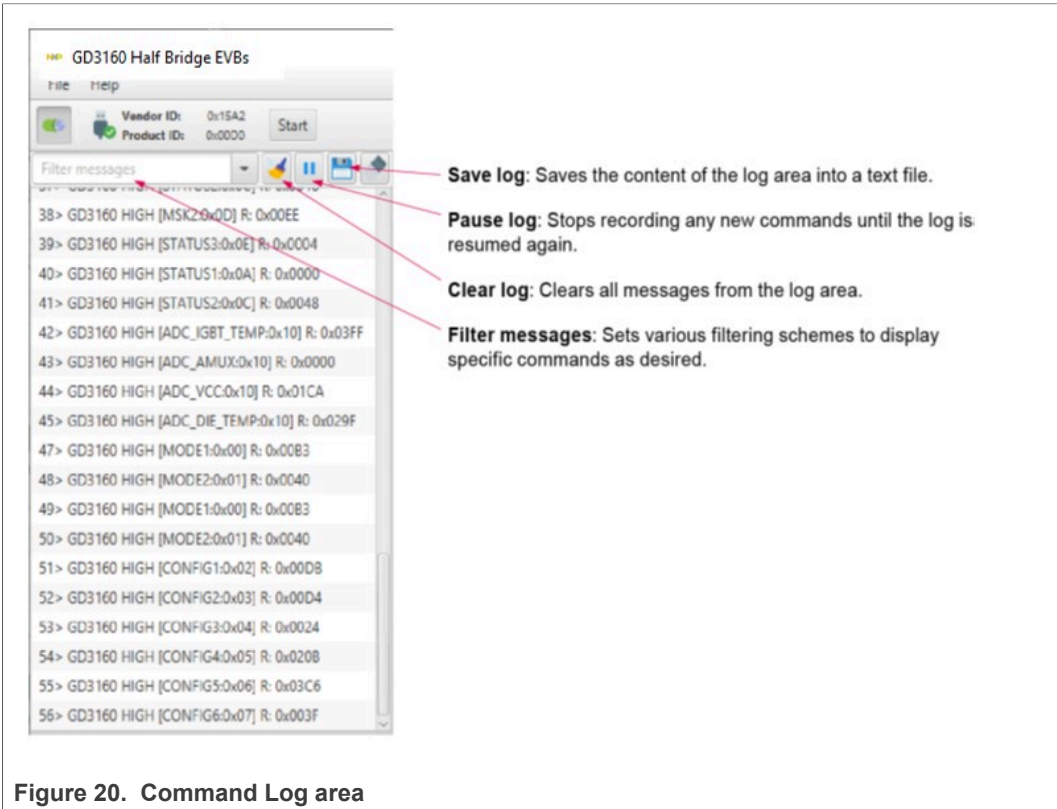


Figure 19. Tabs settings

Command Log window

- The Command Log area informs the user about application events.



Global workspace controls

- Always visible in the lower left corner of the main application window.
 - GD3160 tab functionality
 - Switch modes between run and configuration mode
 - Set SPI frequency

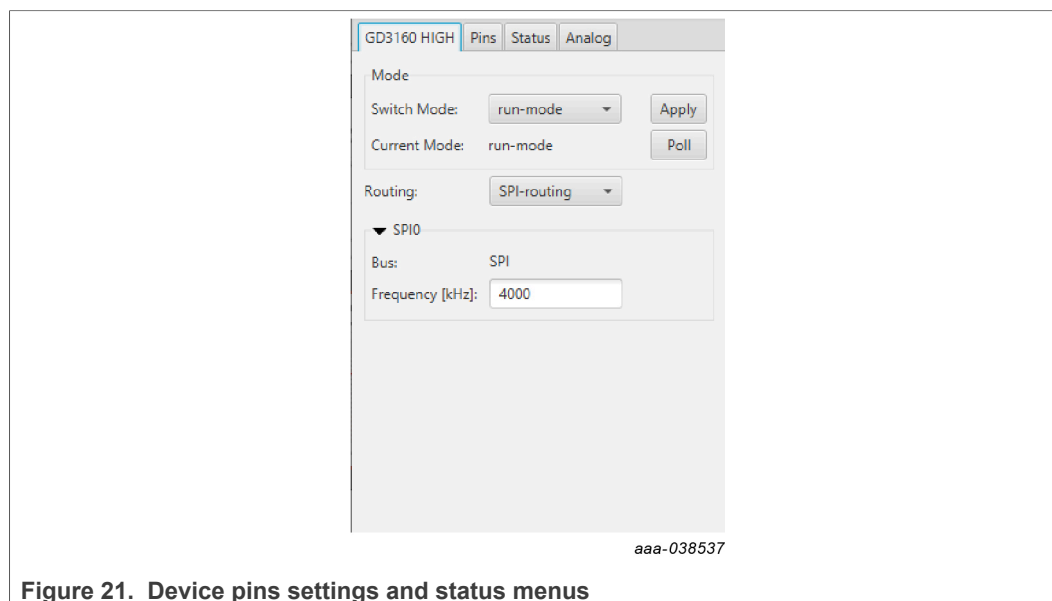


Figure 21. Device pins settings and status menus

- Pins tab functionality
 - Set control levels. Default values are shown.
 - Read and automatically poll INTB pins (INTA pins are added for GD3160).
 - Control pins set values to a default to a functional state.
 - FSENB - enable/disable fail-safe enable
 - EN_PS - enables flyback supply on EVB at 17 V V_{CC} on high side and low side
 - FSSTATEL and FSSTATEH set the fail-safe state when FSENB is enabled
 - PWML and PWMH set the default state PWM inputs for high side and low side

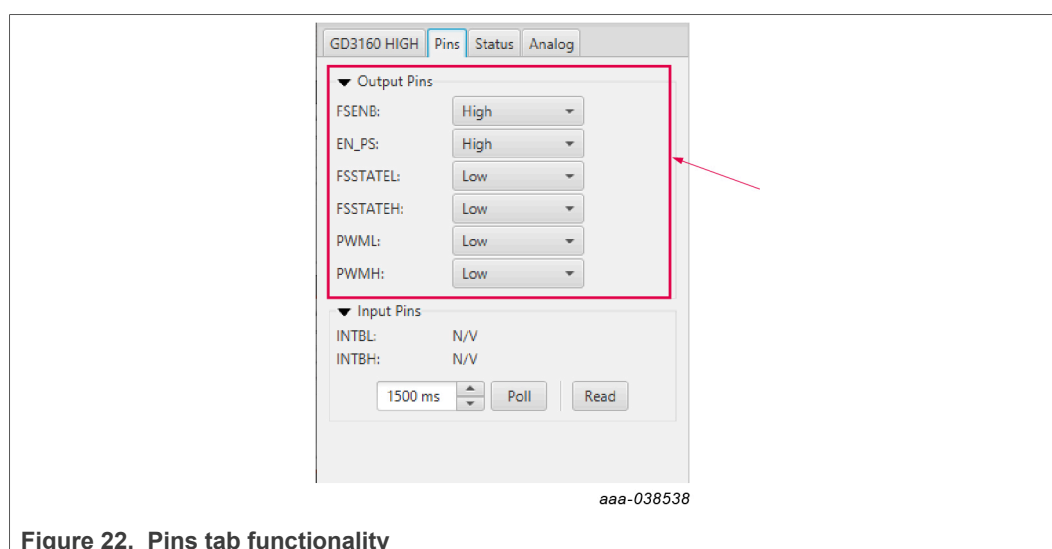
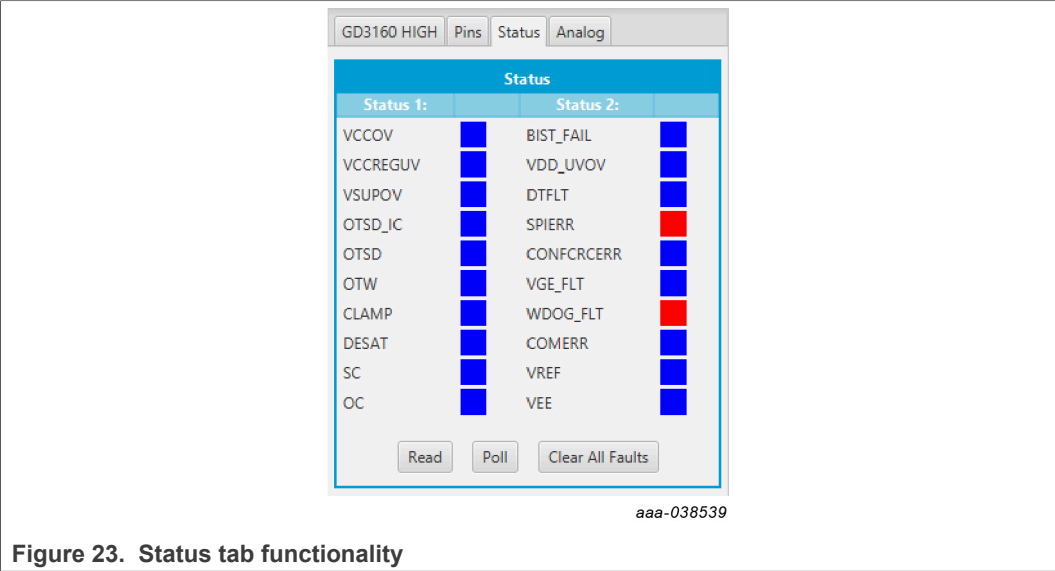


Figure 22. Pins tab functionality

- Status tab functionality
 - Monitors Status 1 and Status 2 fault bits. Bits that are set are shown in red.
 - Ability to clear all faults and automatically poll status registers.



- Analog tab functionality
 - Read and poll ADC values from the high-voltage domain
 - Displays raw ADC and converted values



Register map

- Registers are grouped according to function; independent lines to read and write the registers
- Individual registers can be read by clicking the R button and can be written by using the W button.
- Copy button to copy the read values to the write line; can be set to copy automatically
- Reset button to undo the changes on the write line and reset to the previous value

- Global register controls perform the selected command on all registers with the checkbox selected.

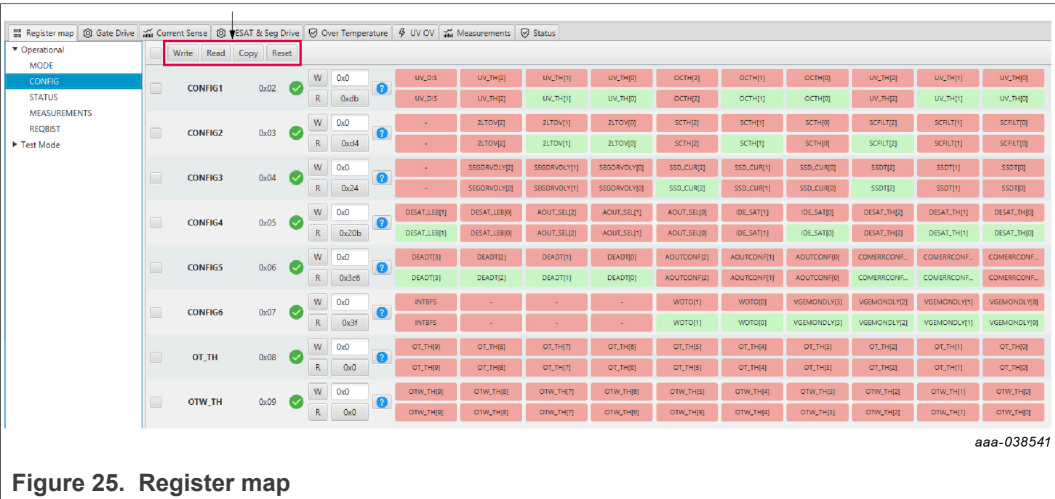


Figure 25. Register map

Gate Drive tab

- Allows setting of parameters related to the gate drive; controls are disabled when not in config mode
- Provides a more intuitive visual way to set parameters
- All settings are automatically synchronized with the register controls.

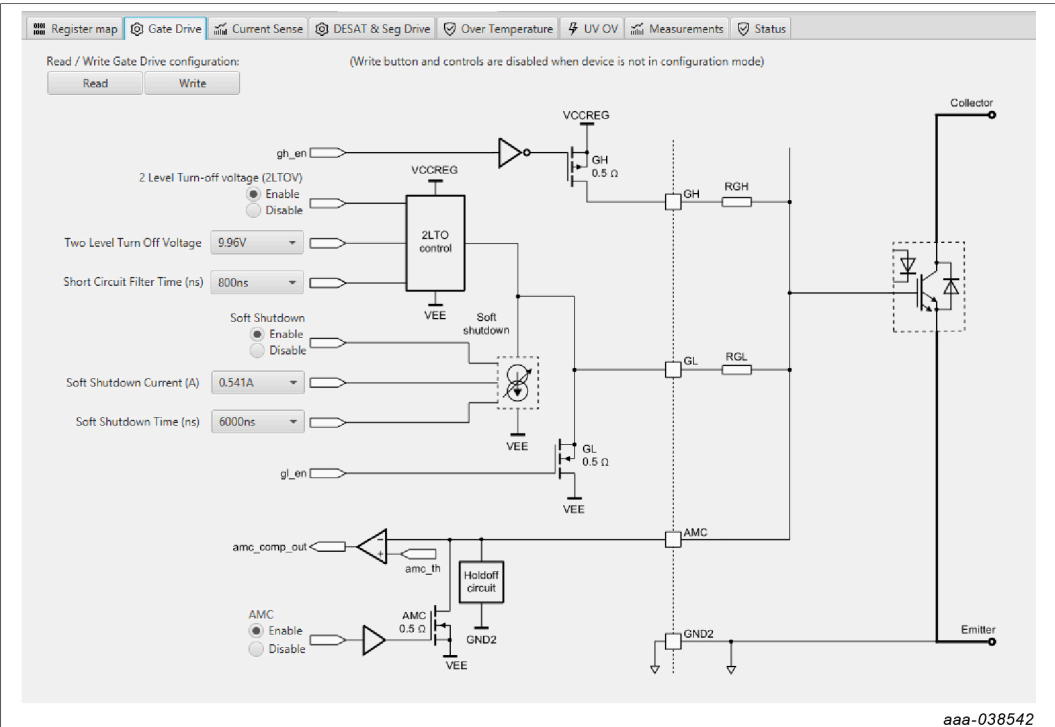


Figure 26. Gate Drive tab

Current Sense tab

- Allows setting of parameters related to current sense
- Provides a more intuitive visual way to set parameters

- All settings are automatically synchronized with the register controls.

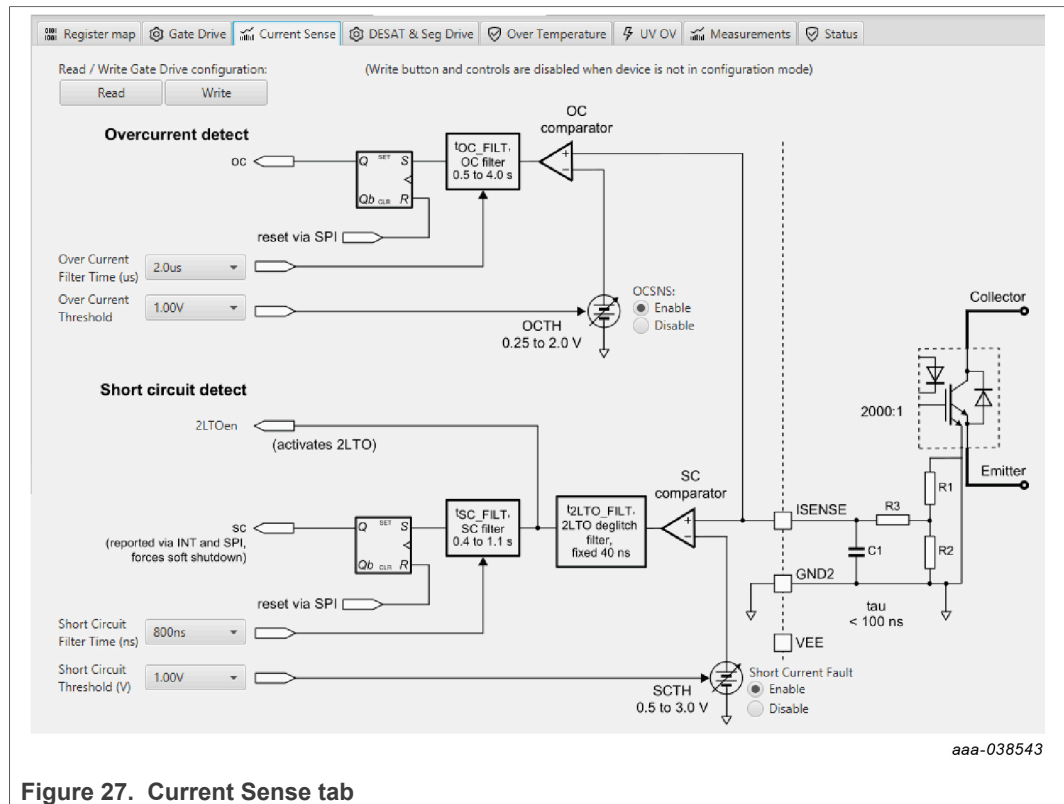


Figure 27. Current Sense tab

DESAT & Seg Drive tab

- Allows setting of parameters related to desat and segmented drive
- Provides a more intuitive visual way to set parameters
- All settings are automatically synchronized with the register controls.

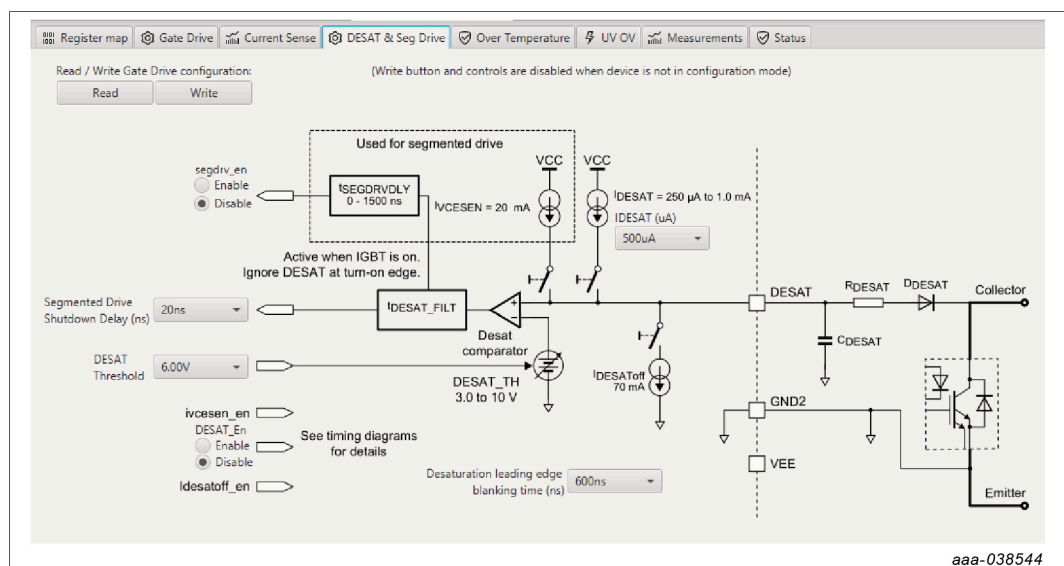


Figure 28. DESAT and Seg Drive tab

Over Temperature tab

- Allows setting of parameters related to overtemperature and overtemperature warning thresholds
- Provides a more intuitive visual way to set parameters
- All settings are automatically synchronized with the register controls.

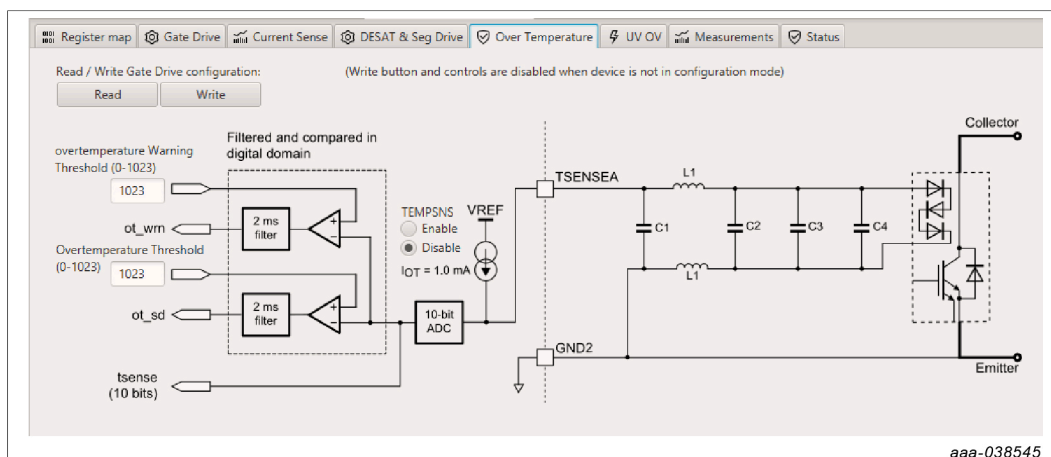


Figure 29. Over Temperature tab

Undervoltage threshold tab

- Allows setting of parameters related to undervoltage threshold
- Provides a more intuitive visual way to set parameters
- All settings are automatically synchronized with the register controls.

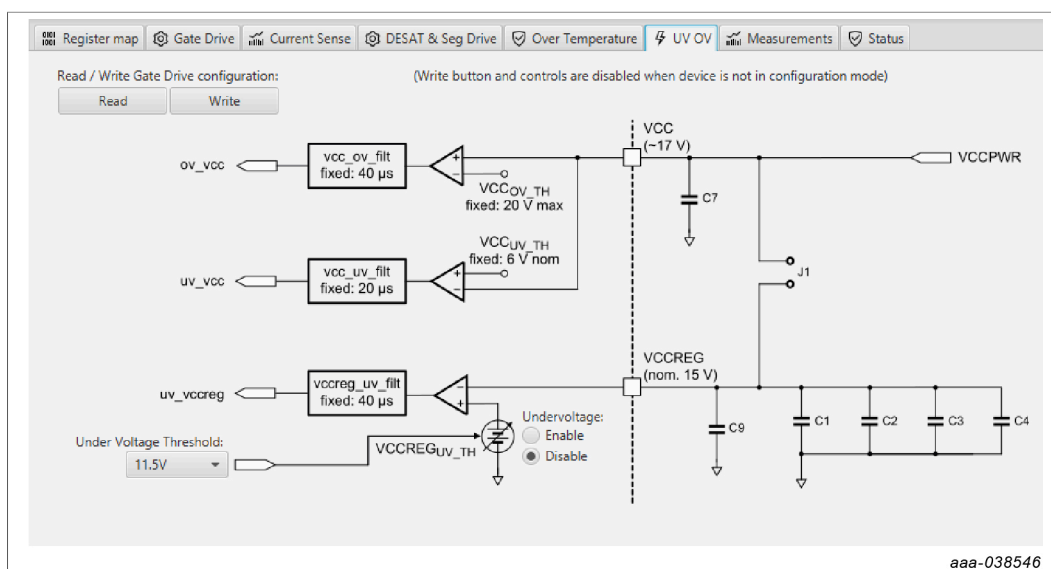
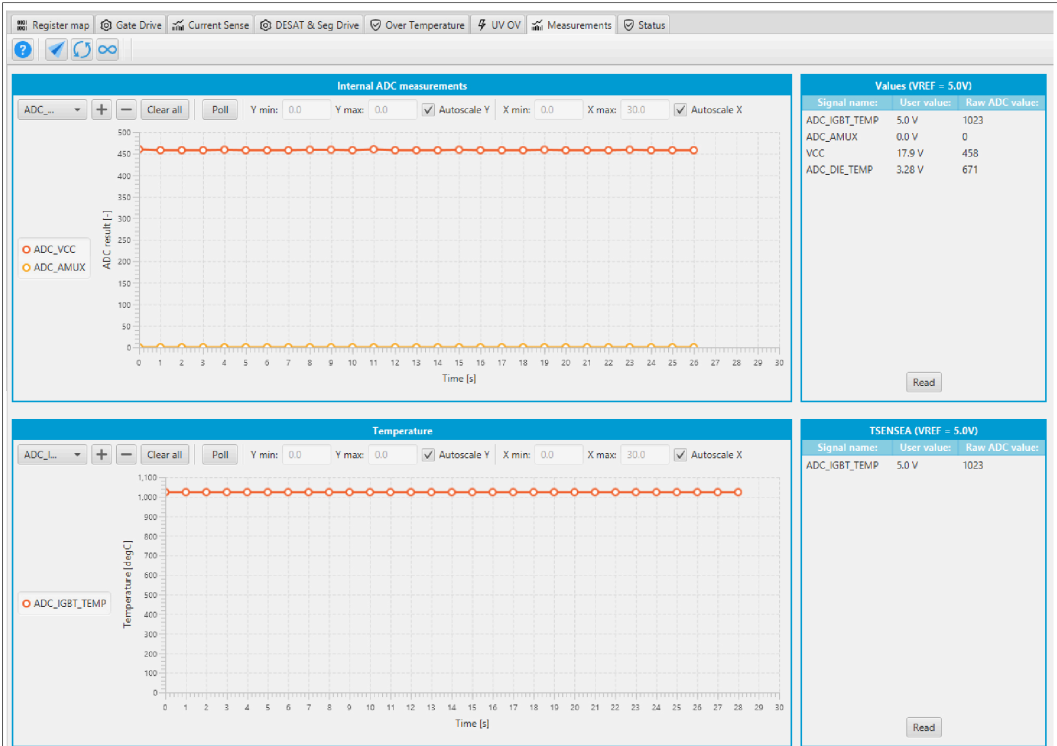


Figure 30. Undervoltage threshold tab

Measurements tab

- Allows monitoring and graphing of ADC and temperature values

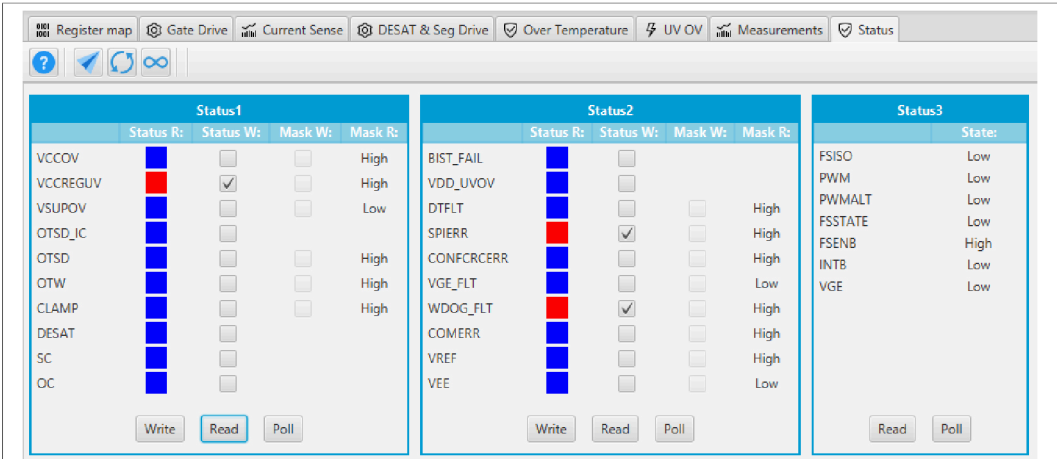


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Figure 31. Measurements tab

Status tab

- Allows monitoring of Status 1, Status 2, and Status 3 register values
- Status 1 and Status 2 faults can be cleared
- Status mask registers can be modified when in configuration mode



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Figure 32. Status tab

Pulse tab

- Used for double pulse, short circuit, and PWM testing
- Select desired T1, T2, and T3 timings for each test type; select enable then generate pulses

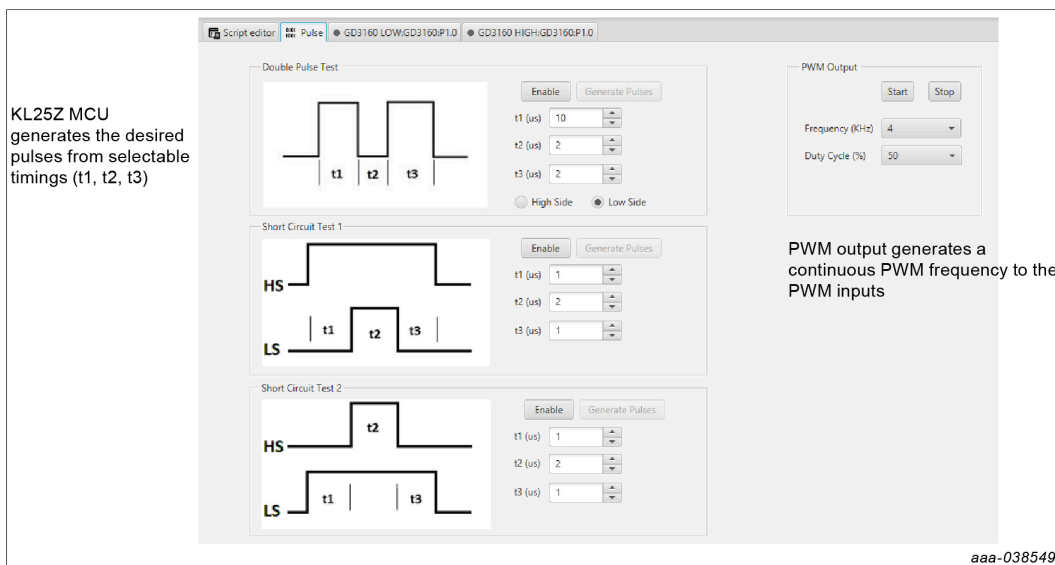


Figure 33. Pulse tab

4.4 Troubleshooting

Some common issues and troubleshooting procedures are detailed below. This is not an exhaustive list by any means, and additional debug may be needed:

Table 9. Troubleshooting

Problem	Evaluation	Explanation	Corrective action(s)
No PWM output (no fault reported)	Check PWM jumper position on translator board	Incorrect PWM jumpers obstruct signal path but not report fault	Set PWMH_SEL (J4) and PWML_SEL (J5) jumpers properly, for desired control method: 3.3 V to 5.0 V translator board reviewed in Section 2.6 "3.3 V to 5.0 V translator board"
	Check PWM control signal	Ensure that proper PWM signal is reaching GD3160	Monitor EXT_PWML (TP14) and EXT_PWMH (TP15) for commanded PWM state
	Check FSEN status (see GD3160 pin 15, STATUS3)	PWM is disabled when FSEN = LOW	Set pin FSEN = HIGH (pin 15) to continue
	Check CONFIG_EN bit (MODE2)	PWM is disabled when CONFIG_EN is logic 1	Write CONFIG_EN = logic 0 to continue
No PWM output (fault reported)	Check VGE fault (VGE_FLT)	A short on IGBT or SiC module gate, or too low of VGEMON delay setting causes VGE fault, locking out PWM control of the gate.	Clear VGE_FLT bit (STATUS2) to continue. Increase VGEMON delay setting (CONFIG6). If safe operating condition can be guaranteed, set VGE_FLTM (MSK2) bit to logic 0, to mask fault.

Table 9. Troubleshooting...continued

	Check for short-circuit fault (SC) in STATUS1 register	SC is a severe fault that disables PWM. SC fault cannot be masked	Clear SC fault to continue. Consider adjusting SC fault settings on GD3160: - Adjust short-circuit threshold setting (CONFIG2) - Adjust short-circuit filter setting (CONFIG2)
PWM output is good, but with persistent fault reported	Check for dead time fault (DTFLT) in STATUS2 register	Dead time is enforced, but fault indicates that PWM controls signals are in violation	Clear DTFLT fault bit (STATUS2). Check PWMALTH_SEL (J17) and PWMALT_L_SEL (J16) are configured to bypass dead time faults. Consider adjusting dead time settings on GD3160: - Change mandatory PWM dead time setting (CONFIG5) - Mask dead time fault (MSK2)
	Check for overcurrent (OC) fault in STATUS1 register	OC fault latches, but does not disable PWM. OC fault cannot be masked.	Clear OC fault bit (STATUS1). Adjust OC fault detection settings on GD3160: - Adjust overcurrent threshold setting (CONFIG1) - Adjust overcurrent filter setting (CONFIG1)
PWM or FSSTATE rising edge has longer delay than falling edge	Check translator output voltage versus GD3160 VDD voltage	Low translator output voltage (compared with correct VDD at GD3160) causes the high threshold at the GD3160 pin to be crossed later than commanded	Check translator output voltage selection (J3) is configured to the same level as the GD3160 VDD. Check VCCSEL supply or translator outputs on the translator board for excessive loading or supply droop/pulldown
WDOG_FLT reported on startup	Check VSUP and VCC are powered	On initialization, watchdog fault is reported when one die is powered up before the other	Check VSUP and VCC both have power applied. Clear WDOG_FLT bit (STATUS2) to continue.
SPIERR reported on startup	Check KL25Z/translator connection	On initialization, SPIERR can occur when the SPI bus is open, or when GD3160 IC is powered up before the translator (which provides CSB).	Clear SPIERR fault to continue. Reinitialize power to GD3160 after translator is powered (over USB).
SPIERR reported after SPI message	Check bit length of message sent	There is SPIERR if SCLK does not see a n*24 multiple of cycles	Use 24-bit message length for SPI messages

Table 9. Troubleshooting...continued

	Check CRC	SPIERR faults if CRC provided in sent message is not good	Use FlexGUI to generate commands with valid CRC. The command can be copied in binary or hexadecimal and sent from another program.
	Check for sufficient dead time between SPI messages	SPIERR fault bit is set when the time between SPI messages (txfer_delay) received is too short. Minimum required delay time is 19 μ s.	Check time between CSB rising edge (old message end) and CSB falling edge (new message start) during normal SPI read, and ensure transfer delay dead time check. SPIERR can also be cleared in BIST.
VCCREGUV reported on startup	Check VCCREG potential	Caused by low VCC	Clear VCCREGUV fault bit (STATUS1). Tune VCC-GNDISO potential with power supply set resistor (R23).
VREFUV reported on startup	Check HV domain is powered correctly	Related to slow rise time of VCC supply on HV domain, or failed VREF regulator	Clear VREFUV bit (STATUS2). Reset HV domain supply if fault bit does not clear.
	Check VCC for undervoltage condition	Low VCC is visible indirectly through other HV domain faults	Tune VCC-GNDISO using R23 feedback
VCCOV fault reported on startup	Check VEE level on suspect domain.	If VEE level is not at desired negative voltage it could cause excessive VCC level.	Check Zener diode in power supply circuit for proper value in setting VEE level. Clear VCCOV bit (STATUS1) to continue.
	Check VCC-GNDISO potential	PWM is disabled during a VCC overvoltage (20 V nom.)	Tune VCC-GNDISO potential to suitable level with power supply set resistor (R23). Clear VCCOV bit (STATUS1) to continue.
No PWM during short circuit test	Check PWMxSEL jumpers	Incorrect configuration of PWMALT pins prevent short-circuit test by enforcing dead time	For short-circuit test, set PWMALTL_SEL (J16) and PWMALTH_SEL (J17) to bypass dead time. See Section 2.4.3 "Power supply and jumper configuration" for details.

Table 9. Troubleshooting...continued

Bad SPI data, appears to repeat previous response	Check VSUP/VDD for undervoltage condition	VDD_UV latches SPI buffer contents, preventing updated fault reporting.	Check voltage provided at VDD pin (pin 3). On each read, compare the address from the sent command and response (a difference indicates that the SPI response is latched due to inactive). Read multiple addresses to ensure a good comparison.
	Check PS_EN is set to HIGH in FlexGUI; see Figure 23	VCC/VEE can be enabled/disabled in software.	Enable VCC/VEE from FlexGUI
	Check VCC for undervoltage	Unpowered VCC prevents HV domain from updating data	Tune VCC-GNDISO using R23 feedback

5 Schematics, Board Layout, and Bill of Materials

The board schematics, board layout, and bill of materials are available at [http://
www.nxp.com/FRDMGD3160DSBHB](http://www.nxp.com/FRDMGD3160DSBHB)

6 References

- [1] **RDGD3160I3PH5EVB** — detailed information on this board, including documentation, downloads, and software and tools
<http://www.nxp.com/%20FRDMGD3160DSBHB>
- [2] **GD3160** — product information on Advanced single-channel gate driver for Insulated Gate Bipolar Transistors
<http://www.nxp.com/FRDMGD3160DSBHB>

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